

Intel[®] Pentium[®] Dual-Core Desktop Processor E2000^{\(\Delta \)} Series

Datasheet

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Intel[®] Pentium[®] Dual-Core Desktop Processor E2000^{\(\Delta\)} Series

- Available at 2.4 GHz, 2.2 GHz, 2.0 GHz, 1.80 GHz, and 1.60 GHz
- Enhanced Intel SpeedStep[®] Technology
- Supports Intel[®] 64 architecture
- Supports Execute Disable Bit capability
- Binary compatible with applications running on previous members of the Intel microprocessor line
- FSB frequency at 800 MHz
- · Advance Dynamic Execution
- · Very deep out-of-order execution
- · Enhanced branch prediction
- Optimized for 32-bit applications running on advanced 32-bit operating systems

- · Two 32-KB Level 1 data caches
- 1 MB Advanced Smart Cache
- · Advanced Digital Media Boost
- Enhanced floating point and multimedia unit for enhanced video, audio, encryption, and 3D performance
- Power Management capabilities
- · System Management mode
- · Multiple low-power states
- 8-way cache associativity provides improved cache hit rate on load/store operations
- 775-land Package

The Intel Pentium[®] Dual-Core desktop processor E2000 series deliver Intel's advanced, powerful processors for desktop PCs. The processor is designed to deliver performance across applications and usages where end-users can truly appreciate and experience the performance. These applications include Internet audio and streaming video, image processing, video content creation, speech, 3D, CAD, games, multimedia, and multitasking user environments.

Intel[®] 64 architecture enables the processor to execute operating systems and applications written to take advantage of the Intel 64 architecture. The processor supporting Enhanced Intel SpeedStep[®] technology allows tradeoffs to be made between performance and power consumption.

The Intel Pentium[®] Dual-Core desktop processor E2000 series also includes the Execute Disable Bit capability. This feature, combined with a supported operating system, allows memory to be marked as executable or non-executable.





Revision History

Revision Number	Description	Date
-001	Initial release	June 2007
-002	Added specifications for Intel [®] Pentium [®] Dual-Core Desktop processor E2180	August 2007
-003	Added specifications for Intel [®] Pentium [®] Dual-Core Desktop processor E2160 and E2140 for a second thermal profile (See Table 26)	September 2007
-004	Added specifications for Intel [®] Pentium [®] Dual-Core Desktop processor E2200	December 2007
-005	Added specifications for Intel [®] Pentium [®] Dual-Core Desktop processor E2220	March 2008





Introduction

The Intel[®] Pentium[®] Dual-Core Desktop processor E2000 series combines the performance of the current generation of desktop products with the power efficiencies of a low-power microarchitecture to enable smaller, quieter systems. These dual-core processors are based on 65 nm process technology. They are 64-bit processors that maintain compatibility with IA-32 software.

The Intel® Pentium® Dual-Core Desktop processor E2000 series uses Flip-Chip Land Grid Array (FC-LGA6) package technology, and plugs into a 775-land surface mount, Land Grid Array (LGA) socket, referred to as the LGA775 socket.

In this document, unless otherwise specified, the Intel® Pentium® Dual-Core Desktop Note:

processor E2000 series refers to Intel® Pentium® Dual-Core Desktop processor E2220,

E2200, E2180, E2160, and E2140.

In this document, unless otherwise specified, the Intel® Pentium® Dual-Core Desktop Note: processor E2000 series is referred to as "processor."

> The processor supports advanced technologies including Execute Disable Bit, Intel® 64 architecture, and Enhanced Intel SpeedStep® technology.

> The processor's front side bus (FSB) uses a split-transaction, deferred reply protocol like the Intel[®] Pentium[®] 4 processor. The FSB uses Source-Synchronous Transfer (SST) of address and data to improve performance by transferring data four times per bus clock (4X data transfer rate, as in AGP 4X). Along with the 4X data bus, the address bus can deliver addresses two times per bus clock and is referred to as a "doubleclocked" or 2X address bus. Working together, the 4X data bus and 2X address bus provide a data bus bandwidth of up to 8.5 GB/s.

> Intel will enable support components for the processor including heatsink, heatsink retention mechanism, and socket. Manufacturability is a high priority; hence, mechanical assembly may be completed from the top of the baseboard and should not require any special tooling.

The processor includes an address bus power-down capability which removes power from the address and data signals when the FSB is not in use. This feature is always enabled on the processor.

1.1 **Terminology**

A '#' symbol after a signal name refers to an active low signal, indicating a signal is in the active state when driven to a low level. For example, when RESET# is low, a reset has been requested. Conversely, when NMI is high, a nonmaskable interrupt has occurred. In the case of signals where the name does not imply an active state but describes part of a binary sequence (such as address or data), the '#' symbol implies that the signal is inverted. For example, D[3:0] = 'HLHL' refers to a hex 'A', and D[3:0]# = LHLH' also refers to a hex 'A' (H= High logic level, L= Low logic level).

Front Side Bus" refers to the interface between the processor and system core logic (a.k.a. the chipset components). The FSB is a multiprocessing interface to processors, memory, and I/O.



1.1.1 Processor Terminology

Commonly used terms are explained here for clarification:

- Intel[®] Pentium[®] Dual-Core Desktop processor E2000 series Dual core processor in the FC-LGA6 package with a 1 MB L2 cache.
- **Processor** For this document, the term processor is the generic form of the Intel[®] Pentium[®] Dual-Core Desktop processor E2000 series. The processor is a single package that contains one or more execution units.
- Keep-out zone The area on or near the processor that system design can not use.
- **Processor core** Processor core die with integrated L2 cache.
- LGA775 socket The processors mate with the system board through a surface mount, 775-land, LGA socket.
- Integrated heat spreader (IHS) —A component of the processor package used to enhance the thermal performance of the package. Component thermal solutions interface with the processor at the IHS surface.
- Retention mechanism (RM) Since the LGA775 socket does not include any
 mechanical features for heatsink attach, a retention mechanism is required.
 Component thermal solutions should attach to the processor via a retention
 mechanism that is independent of the socket.
- FSB (Front Side Bus) The electrical interface that connects the processor to the chipset. Also referred to as the processor system bus or the system bus. All memory and I/O transactions as well as interrupt messages pass between the processor and chipset over the FSB.
- Storage conditions Refers to a non-operational state. The processor may be installed in a platform, in a tray, or loose. Processors may be sealed in packaging or exposed to free air. Under these conditions, processor lands should not be connected to any supply voltages, have any I/Os biased, or receive any clocks. Upon exposure to "free air" (i.e., unsealed packaging or a device removed from packaging material) the processor must be handled in accordance with moisture sensitivity labeling (MSL) as indicated on the packaging material.
- Functional operation Refers to normal operating conditions in which all processor specifications, including DC, AC, system bus, signal quality, mechanical and thermal are satisfied.
- Execute Disable Bit The Execute Disable bit allows memory to be marked as executable or non-executable, when combined with a supporting operating system. If code attempts to run in non-executable memory the processor raises an error to the operating system. This feature can prevent some classes of viruses or worms that exploit buffer over run vulnerabilities and can thus help improve the overall security of the system. See the Intel[®] Architecture Software Developer's Manual for more detailed information.
- Intel[®] 64 Architecture An enhancement to Intel's IA-32 architecture, allowing
 the processor to execute operating systems and applications written to take
 advantage of the Intel 64 architecture. Further details on Intel 64 architecture and
 programming model can be found in the Intel Extended Memory 64 Technology
 Software Developer Guide at http://developer.intel.com/technology/
 64bitextensions/.
- Enhanced Intel SpeedStep® Technology Enhanced Intel SpeedStep technology allows trade-offs to be made between performance and power consumptions, based on processor utilization. This may lower average power consumption (in conjunction with OS support).



1.2 References

Material and concepts available in the following documents may be beneficial when reading this document.

Table 1. References

Document	Location
Intel [®] Pentium [®] Dual-Core Desktop Processor E2000 Series Specification Update	http://www.intel.com// design/processor/ specupdt/316982.htm
Intel [®] Core [™] 2 Duo Processor and Intel [®] Pentium [®] Dual Core Thermal and Mechanical Design Guidelines	http://www.intel.com/ design/processor/ designex/317804.htm
Intel [®] Pentium [®] D Processor, Intel [®] Pentium [®] Processor Extreme Edition, Intel [®] Pentium [®] 4 Processor, and Intel [®] Core [™] 2 Duo Extreme Processor Thermal and Mechanical Design Guidelines.	http://www.intel.com/ design/pentiumXE/ designex/306830.htm
Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket	http://www.intel.com/ design/processor/ applnots/313214.htm
LGA775 Socket Mechanical Design Guide	http://intel.com/ design/Pentium4/ guides/302666.htm
Intel [®] 64 and IA-32 Architecture Software Developer's Manuals	
Intel [®] 64 and IA-32 Architecture Software Developer's Manual Volume 1: Basic Architecture	
Intel [®] 64 and IA-32 Architecture Software Developer's Manual Volume 2A: Instruction Set Reference Manual A–M	http://www.intel.com/
Intel [®] 64 and IA-32 Architecture Software Developer's Manual Volume 2B: Instruction Set Reference Manual, N–Z	products/processor/ manuals/
Intel [®] 64 and IA-32 Architecture Software Developer's Manual Volume 3A: System Programming Guide	
Intel [®] 64 and IA-32 Architecture Software Developer's Manual Volume 3B: System Programming Guide	

§§





2 Electrical Specifications

This chapter describes the electrical characteristics of the processor interfaces and signals. DC electrical characteristics are provided.

2.1 Power and Ground Lands

The processor has VCC (power), VTT and VSS (ground) inputs for on-chip power distribution. All power lands must be connected to V_{CC} , while all VSS lands must be connected to a system ground plane. The processor VCC lands must be supplied the voltage determined by the ${\bf V}$ oltage ${\bf I}$ ${\bf D}$ entification (VID) lands.

The signals denoted as V_{TT} provide termination for the front side bus and power to the I/O buffers. A separate supply must be implemented for these lands, that meets the V_{TT} specifications outlined in Table 5.

2.2 Decoupling Guidelines

Due to its large number of transistors and high internal clock speeds, the processor is capable of generating large current swings. This may cause voltages on power planes to sag below their minimum specified values if bulk decoupling is not adequate. Larger bulk storage (C_{BULK}), such as electrolytic or aluminum-polymer capacitors, supply current during longer lasting changes in current demand by the component, such as coming out of an idle condition. Similarly, they act as a storage well for current when entering an idle condition from a running condition. The motherboard must be designed to ensure that the voltage provided to the processor remains within the specifications listed in Table 5. Failure to do so can result in timing violations or reduced lifetime of the component.

2.2.1 V_{CC} Decoupling

V_{CC} regulator solutions need to provide sufficient decoupling capacitance to satisfy the processor voltage specifications. This includes bulk capacitance with low effective series resistance (ESR) to keep the voltage rail within specifications during large swings in load current. In addition, ceramic decoupling capacitors are required to filter high frequency content generated by the front side bus and processor activity. Consult the *Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket* for further information.

2.2.2 V_{TT} Decoupling

Decoupling must be provided on the motherboard. Decoupling solutions must be sized to meet the expected load. To ensure compliance with the specifications, various factors associated with the power delivery solution must be considered including regulator type, power plane and trace sizing, and component placement. A conservative decoupling solution would consist of a combination of low ESR bulk capacitors and high frequency ceramic capacitors.



2.2.3 FSB Decoupling

The processor integrates signal termination on the die. In addition, some of the high frequency capacitance required for the FSB is included on the processor package. However, additional high frequency capacitance must be added to the motherboard to properly decouple the return currents from the front side bus. Bulk decoupling must also be provided by the motherboard for proper [A]GTL+ bus operation.

2.3 Voltage Identification

The Voltage Identification (VID) specification for the processor is defined by the *Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket.* The voltage set by the VID signals is the reference VR output voltage to be delivered to the processor VCC pins (see Section 2.6.3 for V_{CC} overshoot specifications). Refer to Table 13 for the DC specifications for these signals. Voltages for each processor frequency is provided in Table 5.

Individual processor VID values may be calibrated during manufacturing such that two devices at the same core speed may have different default VID settings. This is reflected by the VID Range values provided in Table 5. Refer to the Intel® Pentium® Dual-Core Desktop Processor E2000 Series Specification Update for further details on specific valid core frequency and VID values of the processor. Note this differs from the VID employed by the processor during a power management event (Thermal Monitor 2, Enhanced Intel SpeedStep® Technology, or Enhanced HALT State).

The processor uses six voltage identification signals, VID[6:1], to support automatic selection of power supply voltages. Table 2 specifies the voltage level corresponding to the state of VID[6:1]. A '1' in this table refers to a high voltage level and a '0' refers to a low voltage level. If the processor socket is empty (VID[6:1] = 1111111), or the voltage regulation circuit cannot supply the voltage that is requested, it must disable itself. The *Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket* defines VID [7:0], VID7 and VID0 are not used on the processor; VID0 and VID7 are strapped to V_{SS} on the processor package. VID0 and VID7 must be connected to the VR controller for compatibility with future processors.

The processor provides the ability to operate while transitioning to an adjacent VID and its associated processor core voltage (V_{CC}). This will represent a DC shift in the load line. It should be noted that a low-to-high or high-to-low voltage state change may result in as many VID transitions as necessary to reach the target core voltage. Transitions above the specified VID are not permitted. Table 5 includes VID step sizes and DC shift ranges. Minimum and maximum voltages must be maintained as shown in Table 6 and Figure 1 as measured across the VCC_SENSE and VSS_SENSE lands.

The VRM or VRD used must be capable of regulating its output to the value defined by the new VID. DC specifications for dynamic VID transitions are included in Table 5 and Table 6. Refer to the *Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket* for further details.



Table 2. Voltage Identification Definition

VID6	VID5	VID4	VID3	VID2	VID1	V _{CC_MAX}
1	1	1	1	0	1	0.8500
1	1	1	1	0	0	0.8625
1	1	1	0	1	1	0.8750
1	1	1	0	1	0	0.8875
1	1	1	0	0	1	0.9000
1	1	1	0	0	0	0.9125
1	1	0	1	1	1	0.9250
1	1	0	1	1	0	0.9375
1	1	0	1	0	1	0.9500
1	1	0	1	0	0	0.9625
1	1	0	0	1	1	0.9750
1	1	0	0	1	0	0.9875
1	1	0	0	0	1	1.0000
1	1	0	0	0	0	1.0125
1	0	1	1	1	1	1.0250
1	0	1	1	1	0	1.0375
1	0	1	1	0	1	1.0500
1	0	1	1	0	0	1.0625
1	0	1	0	1	1	1.0750
1	0	1	0	1	0	1.0875
1	0	1	0	0	1	1.1000
1	0	1	0	0	0	1.1125
1	0	0	1	1	1	1.1250
1	0	0	1	1	0	1.1375
1	0	0	1	0	1	1.1500
1	0	0	1	0	0	1.1625
1	0	0	0	1	1	1.1750
1	0	0	0	1	0	1.1875
1	0	0	0	0	1	1.2000
1	0	0	0	0	0	1.2125
0	1	1	1	1	1	1.2250

VID6	VID5	VID4	VID3	VID2	VID1	V _{CC_MAX}
0	1	1	1	1	0	1.2375
0	1	1	1	0	1	1.2500
0	1	1	1	0	0	1.2625
0	1	1	0	1	1	1.2750
0	1	1	0	1	0	1.2875
0	1	1	0	0	1	1.3000
0	1	1	0	0	0	1.3125
0	1	0	1	1	1	1.3250
0	1	0	1	1	0	1.3375
0	1	0	1	0	1	1.3500
0	1	0	1	0	0	1.3625
0	1	0	0	1	1	1.3750
0	1	0	0	1	0	1.3875
0	1	0	0	0	1	1.4000
0	1	0	0	0	0	1.4125
0	0	1	1	1	1	1.4250
0	0	1	1	1	0	1.4375
0	0	1	1	0	1	1.4500
0	0	1	1	0	0	1.4625
0	0	1	0	1	1	1.4750
0	0	1	0	1	0	1.4875
0	0	1	0	0	1	1.5000
0	0	1	0	0	0	1.5125
0	0	0	1	1	1	1.5250
0	0	0	1	1	0	1.5375
0	0	0	1	0	1	1.5500
0	0	0	1	0	0	1.5625
0	0	0	0	1	1	1.5750
0	0	0	0	1	0	1.5875
0	0	0	0	0	1	1.6000
0	0	0	0	0	0	OFF



2.4 Market Segment Identification (MSID)

The MSID[1:0] signals may be used as outputs to determine the Market Segment of the processor. Table 3 provides details regarding the state of MSID[1:0]. A circuit can be used to prevent 130 W TDP processors from booting on boards optimized for 65 W TDP.

Table 3. Market Segment Selection Truth Table for MSID[1:0]^{1, 2, 3, 4}

MSID1	MSIDO	Description
0	0	Intel [®] Pentium [®] Dual-Core Desktop processor E2000 series
0	1	Reserved
1	0	Reserved
1	1	Reserved

NOTES:

- 1. The MSID[1:0] signals are provided to indicate the Market Segment for the processor and may be used for future processor compatibility or for keying. Circuitry on the motherboard may use these signals to identify the processor installed.
- 2. These signals are not connected to the processor die.
- 3. A logic 0 is achieved by pulling the signal to ground on the package.
- 4. A logic 1 is achieved by leaving the signal as a no connect on the package.

2.5 Reserved, Unused, and TESTHI Signals

All RESERVED lands must remain unconnected. Connection of these lands to V_{CC} , V_{SS} , V_{TT} , or to any other signal (including each other) can result in component malfunction or incompatibility with future processors. See Chapter 4 for a land listing of the processor and the location of all RESERVED lands.

In a system level design, on-die termination has been included by the processor to allow signals to be terminated within the processor silicon. Most unused GTL+ inputs should be left as no connects as GTL+ termination is provided on the processor silicon. However, see Table 8 for details on GTL+ signals that do not include on-die termination.

Unused active high inputs, should be connected through a resistor to ground (V_{SS}). Unused outputs can be left unconnected, however this may interfere with some TAP functions, complicate debug probing, and prevent boundary scan testing. A resistor must be used when tying bidirectional signals to power or ground. When tying any signal to power or ground, a resistor will also allow for system testability. Resistor values should be within \pm 20% of the impedance of the motherboard trace for front side bus signals. For unused GTL+ input or I/O signals, use pull-up resistors of the same value as the on-die termination resistors (R_{TT}). For details, see Table 14.

TAP and CMOS signals do not include on-die termination. Inputs and used outputs must be terminated on the motherboard. Unused outputs may be terminated on the motherboard or left unconnected. Note that leaving unused outputs unterminated may interfere with some TAP functions, complicate debug probing, and prevent boundary scan testing.

All TESTHI[13:0] lands should be individually connected to V_{TT} via a pull-up resistor that matches the nominal trace impedance.



The TESTHI signals may use individual pull-up resistors or be grouped together as detailed below. A matched resistor must be used for each group:

- TESTHI[1:0]
- TESTHI[7:2]
- TESTHI8/FC42 cannot be grouped with other TESTHI signals
- TESTHI9/FC43 cannot be grouped with other TESTHI signals
- TESTHI10 cannot be grouped with other TESTHI signals
- TESTHI11 cannot be grouped with other TESTHI signals
- TESTHI12/FC44 cannot be grouped with other TESTHI signals
- TESTHI13 cannot be grouped with other TESTHI signals

However, use of boundary scan test will not be functional if these lands are connected together. For optimum noise margin, all pull-up resistor values used for TESTHI[13:0] lands should have a resistance value within \pm 20% of the impedance of the board transmission line traces. For example, if the nominal trace impedance is 50 Ω , then a value between 40 Ω and 60 Ω should be used.

2.6 Voltage and Current Specification

2.6.1 Absolute Maximum and Minimum Ratings

Table 4 specifies absolute maximum and minimum ratings only and lie outside the functional limits of the processor. Within functional operation limits, functionality and long-term reliability can be expected.

At conditions outside functional operation condition limits, but within absolute maximum and minimum ratings, neither functionality nor long-term reliability can be expected. If a device is returned to conditions within functional operation limits after having been subjected to conditions outside these limits, but within the absolute maximum and minimum ratings, the device may be functional, but with its lifetime degraded depending on exposure to conditions exceeding the functional operation condition limits.

At conditions exceeding absolute maximum and minimum ratings, neither functionality nor long-term reliability can be expected. Moreover, if a device is subjected to these conditions for any length of time then, when returned to conditions within the functional operating condition limits, it will either not function, or its reliability will be severely degraded.

Although the processor contains protective circuitry to resist damage from static electric discharge, precautions should always be taken to avoid high static voltages or electric fields.



Table 4. Absolute Maximum and Minimum Ratings

Symbol	Parameter	Min	Max	Unit	Notes ^{1, 2}
V _{CC}	Core voltage with respect to V _{SS}	-0.3	1.55	V	-
V _{TT}	FSB termination voltage with respect to V _{SS}	-0.3	1.55	V	-
T _C	Processor case temperature	See Chapter 5	See Chapter 5	°C	-
T _{STORAGE}	Processor storage temperature	-40	85	°C	3, 4, 5

NOTES:

- For functional operation, all processor electrical, signal quality, mechanical and thermal specifications must be satisfied.
- 2. Excessive overshoot or undershoot on any signal will likely result in permanent damage to the processor.
- Storage temperature is applicable to storage conditions only. In this scenario, the
 processor must not receive a clock, and no lands can be connected to a voltage bias.
 Storage within these limits will not affect the long-term reliability of the device. For
 functional operation, refer to the processor case temperature specifications.
- 4. This rating applies to the processor and does not include any tray or packaging.
- 5. Failure to adhere to this specification can affect the long term reliability of the processor.



2.6.2 DC Voltage and Current Specification

Table 5. **Voltage and Current Specifications**

Symbol	Par	ameter	Min	Тур	Max	Unit	Notes ^{1, 2}
VID Range	VID		0.8500	_	1.5	V	3
	Processor Number	V _{CC} for 775_VR_CONFIG_06		•	1		
	E2220	2.4 GHz	5.6				
V _{CC}	E2200	2.2 GHz	Refer	to Table 1		V	4, 5, 6
	E2180	2.0 GHz		Table I			
	E2160	1.8 GHz					
	E2140	1.6 GHz					
V _{CC_BOOT}	Default V _{CC} voltage	for initial power up	_	1.10	_	V	
V _{CCPLL}	PLL V _{CC}		- 5%	1.50	+ 5%		
	Processor Number	V _{CC} for 775_VR_CONFIG_06					
	E2220	2.4 GHz			75		_
I _{CC}	E2200	2.2 GHz	_	_	75	Α	7
	E2180	2.0 GHz			75		
	E2160	1.8 GHz			75		
	E2140	1.6 GHz			75		
V_{TT}	FSB termination vol (DC + AC specificat	· ·	1.14	1.20	1.26	V	8
VTT_OUT_LEFT and VTT_OUT_RIGHT I _{CC}	DC Current that ma VTT_OUT_LEFT and pin	y be drawn from I VTT_OUT_RIGHT per	_	_	580	mA	9
-66	'	efore Voc stable			4.5		
I _{TT}	I_{CC} for V_{TT} supply before V_{CC} stable I_{CC} for V_{TT} supply after V_{CC} stable		<u> </u>	_	4.6	Α	10
I _{CC_VCCPLL}	I _{CC} for PLL land		_	_	130	mA	
I _{CC_GTLREF}	I _{CC} for GTLREF		_	_	200	μА	

NOTES:

- 1. Unless otherwise noted, all specifications in this table are based on estimates and simulations or empirical data. These specifications will be updated with characterized data from silicon measurements at a later date.
- Adherence to the voltage specifications for the processor are required to ensure reliable processor operation.
 Each processor is programmed with a maximum valid voltage identification value (VID), which is set at manufacturing and can not be altered. Individual maximum VID values are calibrated during manufacturing such that two processors at the same frequency may have different settings within the VID range. Note this differs from the VID employed by the processor during a power management event (Thermal Monitor 2, Enhanced Intel SpeedStep® technology, or Extended HALT State).
- 4. These voltages are targets only. A variable voltage source should exist on systems in the event that a different voltage is required. See Section 2.3 and Table 2 for more information.
- The voltage specification requirements are measured across VCC_SENSE and VSS_SENSE lands at the socket with a 100 MHz bandwidth oscilloscope, 1.5 pF maximum probe capacitance, and 1 M Ω minimum impedance. The maximum length of ground wire on the probe should be less than 5 mm. Ensure external noise from the system
- is not coupled into the oscilloscope probe.

 6. Refer to Table 6 and Figure 1 for the minimum, typical, and maximum V_{CC} allowed for a given current. The processor should not be subjected to any V_{CC} and I_{CC} combination wherein V_{CC} exceeds V_{CC_MAX} for a given
- I_{CC_MAX} specification is based on the V_{CC_MAX} loadline. Refer to Figure 1 for details.
 V_{TT} must be provided via a separate voltage source and not be connected to V_{CC}. This specification is measured at the land.
- Baseboard bandwidth is limited to 20 MHz.
- 10. This is maximum total current drawn from V_{TT} plane by only the processor. This specification does not include the current coming from R_{TT} (through the signal line). Refer to the Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket to determine the total I_{TT} drawn by the system. This parameter is based on design characterization and is not tested.



Table 6. **V_{CC} Static and Transient Tolerance for Processors**

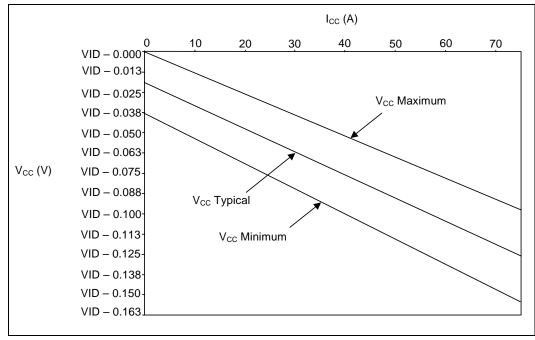
	Voltage Deviation from VID Setting (V) ^{1, 2, 3, 4}							
I _{CC} (A)	Maximum Voltage 1.30 mΩ	Typical Voltage 1.425 mΩ	Minimum Voltage 1.55 mΩ					
0	0.000	-0.019	-0.038					
5	-0.007	-0.026	-0.046					
10	-0.013	-0.033	-0.054					
15	-0.020	-0.040	-0.061					
20	-0.026	-0.048	-0.069					
25	-0.033	-0.055	-0.077					
30	-0.039	-0.062	-0.085					
35	-0.046	-0.069	-0.092					
40	-0.052	-0.076	-0.100					
45	-0.059	-0.083	-0.108					
50	-0.065	-0.090	-0.116					
55	-0.072	-0.097	-0.123					
60	-0.078	-0.105	-0.131					
65	-0.085	-0.112	-0.139					
70	-0.091	-0.119	-0.147					
75	-0.098	-0.126	-0.154					

NOTES:

- NOTES:
 The loadline specification includes both static and transient limits except for overshoot allowed as shown in Section 2.6.3.
 This table is intended to aid in reading discrete points on Figure 1.
 The loadlines specify voltage limits at the die measured at the VCC_SENSE and VSS_SENSE lands. Voltage regulation feedback for voltage regulator circuits must be taken from processor VCC and VSS lands. Refer to the Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket for socket loadline guidelines and VR implementation details.
 Adherence to this loadline specification is required to ensure reliable processor operation.
- 4. Adherence to this loadline specification is required to ensure reliable processor operation.



Figure 1. V_{CC} Static and Transient Tolerance for Processors



NOTES:

- The loadline specification includes both static and transient limits except for overshoot allowed as shown in Section 2.6.3.
- 2. This loadline specification shows the deviation from the VID set point.
- 3. The loadlines specify voltage limits at the die measured at the VCC_SENSE and VSS_SENSE lands. Voltage regulation feedback for voltage regulator circuits must be taken from processor VCC and VSS lands. Refer to the Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket for socket loadline guidelines and VR implementation details.

2.6.3 V_{cc} Overshoot

The processor can tolerate short transient overshoot events where V_{CC} exceeds the VID voltage when transitioning from a high to low current load condition. This overshoot cannot exceed VID + V_{OS_MAX} (V_{OS_MAX} is the maximum allowable overshoot voltage). The time duration of the overshoot event must not exceed T_{OS_MAX} (T_{OS_MAX} is the maximum allowable time duration above VID). These specifications apply to the processor die voltage as measured across the VCC_SENSE and VSS_SENSE lands.

Table 7. V_{CC} Overshoot Specifications

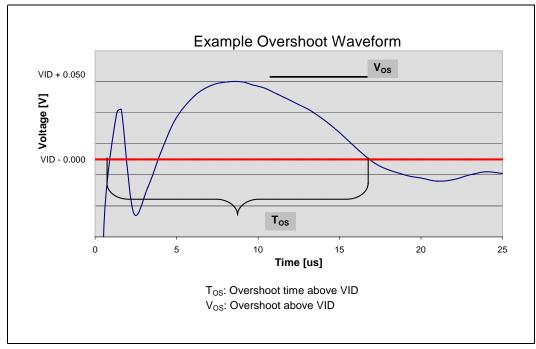
Symbol	Parameter	Min	Max	Unit	Figure	Notes
V _{OS_MAX}	Magnitude of V _{CC} overshoot above VID	_	50	mV	2	1
T _{OS_MAX}	Time duration of V_{CC} overshoot above VID	_	25	μS	2	1

NOTES:

1. Adherence to these specifications is required to ensure reliable processor operation.



Figure 2. V_{CC} Overshoot Example Waveform



NOTES:

- V_{OS} is measured overshoot voltage.
- 2. T_{OS} is measured time duration above VID.

2.6.4 Die Voltage Validation

Overshoot events on processor must meet the specifications in Table 7 when measured across the VCC_SENSE and VSS_SENSE lands. Overshoot events that are < 10 ns in duration may be ignored. These measurements of processor die level overshoot must be taken with a bandwidth limited oscilloscope set to a greater than or equal to 100 MHz bandwidth limit.

2.7 Signaling Specifications

Most processor Front Side Bus signals use Gunning Transceiver Logic (GTL+) signaling technology. This technology provides improved noise margins and reduced ringing through low voltage swings and controlled edge rates. Platforms implement a termination voltage level for GTL+ signals defined as V_{TT} . Because platforms implement separate power planes for each processor (and chipset), separate V_{CC} and V_{TT} supplies are necessary. This configuration allows for improved noise tolerance as processor frequency increases. Speed enhancements to data and address busses have caused signal integrity considerations and platform design methods to become even more critical than with previous processor families. The GTL+ inputs require a reference voltage (GTLREF) which is used by the receivers to determine if a signal is a logical 0 or a logical 1. GTLREF must be generated on the motherboard (see Table 14 for GTLREF specifications). Termination resistors (R_{TT}) for GTL+ signals are provided on the processor silicon and are terminated to V_{TT} . Intel chipsets will also provide on-die termination, thus eliminating the need to terminate the bus on the motherboard for most GTL+ signals.



2.7.1 FSB Signal Groups

The front side bus signals have been combined into groups by buffer type. GTL+ input signals have differential input buffers, which use GTLREF[1:0] as a reference level. In this document, the term "GTL+ Input" refers to the GTL+ input group as well as the GTL+ I/O group when receiving. Similarly, "GTL+ Output" refers to the GTL+ output group as well as the GTL+ I/O group when driving.

With the implementation of a source synchronous data bus comes the need to specify two sets of timing parameters. One set is for common clock signals which are dependent upon the rising edge of BCLKO (ADS#, HIT#, HITM#, etc.) and the second set is for the source synchronous signals which are relative to their respective strobe lines (data and address) as well as the rising edge of BCLKO. Asychronous signals are still present (A20M#, IGNNE#, etc.) and can become active at any time during the clock cycle. Table 8 identifies which signals are common clock, source synchronous, and asynchronous.

Table 8. FSB Signal Groups

Signal Group	Туре	Siç	gnals ¹	
GTL+ Common Clock Input	Synchronous to BCLK[1:0]	BPRI#, DEFER#, RESET#,	RS[2:0]#, TRDY#	
GTL+ Common Clock I/O	Synchronous to BCLK[1:0]	ADS#, BNR#, BPM[5:0]#, HITM#, LOCK#	BRO#, DBSY#, DRDY#, HIT#,	
		Signals	Associated Strobe	
GTL+ Source Synchronous I/O		REQ[4:0]#, A[16:3]# ³	ADSTB0#	
	Synchronous to	A[35:17]# ³	ADSTB1#	
	assoc. strobe	D[15:0]#, DBI0#	DSTBP0#, DSTBN0#	
		D[31:16]#, DBI1#	DSTBP1#, DSTBN1#	
		D[47:32]#, DBI2#	DSTBP2#, DSTBN2#	
		D[63:48]#, DBI3#	DSTBP3#, DSTBN3#	
GTL+ Strobes	Synchronous to BCLK[1:0]	ADSTB[1:0]#, DSTBP[3:0]	#, DSTBN[3:0]#	
CMOS		A20M#, IGNNE#, INIT#, L STPCLK#, PWRGOOD, TCK BSEL[2:0], VID[6:1]	INTO/INTR, LINT1/NMI, SMI#, , TDI, TMS, TRST#,	
Open Drain Output		FERR#/PBE#, IERR#, THE	RMTRIP#, TDO	
Open Drain Input/Output		PROCHOT# ⁴		
FSB Clock	Clock	BCLK[1:0], ITP_CLK[1:0] ²		
Power/Other		VCC, VTT, VCCA, VCCIOPLL, VCCPLL, VSS, VSSA, GTLREF[1:0], COMP[8,3:0], RESERVED, TESTHI[13:0], VCC_SENSE, VCC_MB_REGULATION, VSS_SENSE, VSS_MB_REGULATION, DBR#2, VTT_OUT_LEFT, VTT_OUT_RIGHT, VTT_SEL, FCx, PECI, MSID[1:0]		

NOTES:

- 1. Refer to Section 4.2 for signal descriptions.
- 2. In processor systems where no debug port is implemented on the system board, these signals are used to support a debug port interposer. In systems with the debug port implemented on the system board, these signals are no connects.



- 3. The value of these signals during the active-to-inactive edge of RESET# defines the processor configuration options. See Section 6.1 for details.
- 4. PROCHOT# signal type is open drain output and CMOS input.

Table 9. Signal Characteristics

Signals with R _{TT}	Signals with No R _{TT}
A[35:3]#, ADS#, ADSTB[1:0]#, BNR#, BPRI#, D[63:0]#, DBI[3:0]#, DBSY#, DEFER#, DRDY#, DSTBN[3:0]#, DSTBP[3:0]#, HIT#, HITM#, LOCK#, PROCHOT#, REQ[4:0]#, RS[2:0]#, TRDY#	A20M#, BCLK[1:0], BSEL[2:0], COMP[8,3:0], IGNNE#, INIT#, ITP_CLK[1:0], LINTO/INTR, LINT1/NMI, PWRGOOD, RESET#, SMI#, STPCLK#, TESTHI[13:0], VID[6:1], GTLREF[1:0], TCK, TDI, TMS, TRST#, VTT_SEL, MSID[1:0]
Open Drain Signals ¹	
THERMTRIP#, FERR#/PBE#, IERR#, BPM[5:0]#, BRO#, TDO, FCx	

NOTES:

1. Signals that do not have R_{TT}, nor are actively driven to their high-voltage level.

Table 10. Signal Reference Voltages

GTLREF	V _{TT} /2
BPM[5:0]#, RESET#, BNR#, HIT#, HITM#, BRO#, A[35:0]#, ADS#, ADSTB[1:0]#, BPRI#, D[63:0]#, DBI[3:0]#, DBSY#, DEFER#, DRDY#, DSTBN[3:0]#, DSTBP[3:0]#, LOCK#, REQ[4:0]#, RS[2:0]#, TRDY#	A20M#, LINTO/INTR, LINT1/NMI, IGNNE#, INIT#, PROCHOT#, PWRGOOD ¹ , SMI#, STPCLK#, TCK ¹ , TDI ¹ , TMS ¹ , TRST# ¹

NOTES:

2.7.2 CMOS and Open Drain Signals

Legacy input signals such as A20M#, IGNNE#, INIT#, SMI#, and STPCLK# use CMOS input buffers. All of the CMOS and Open Drain signals are required to be asserted/deasserted for at least four BCLKs in order for the processor to recognize the proper signal state. See Section 2.7.3 for the DC specifications. See Section 6.2 for additional timing requirements for entering and leaving the low power states.

^{1.} These signals also have hysteresis added to the reference voltage. See Table 12 for more information.



2.7.3 **Processor DC Specifications**

The processor DC specifications in this section are defined at the processor core (pads) unless otherwise stated. All specifications apply to all frequencies and cache sizes unless otherwise stated.

Table 11. **GTL+ Signal Group DC Specifications**

Symbol	Parameter	Min	Max	Unit	Notes ¹
V _{IL}	Input Low Voltage	-0.10	GTLREF – 0.10	V	2, 3
V _{IH}	Input High Voltage	GTLREF + 0.10	V _{TT} + 0.10	V	4, 5, 3
V _{OH}	Output High Voltage	V _{TT} – 0.10	V _{TT}	V	5, 3
I _{OL}	Output Low Current	N/A	$V_{TT_MAX}/$ [(R _{TT_MIN})+(2*R _{ON_MIN})]	Α	-
I _{LI}	Input Leakage Current	N/A	± 100	μΑ	6
I _{LO}	Output Leakage Current	N/A	± 100	μΑ	7
R _{ON}	Buffer On Resistance	10	13	Ω	

NOTES:

- Unless otherwise noted, all specifications in this table apply to all processor frequencies.
 V_{IL} is defined as the voltage range at a receiving agent that will be interpreted as a logical low value.
 The V_{TT} referred to in these specifications is the instantaneous V_{TT}.
 V_{IH} is defined as the voltage range at a receiving agent that will be interpreted as a logical high value.

- VI_II is defined as the testing the value.
 V_{IH} and V_{OH} may experience excursions above V_{TT}. However, input signal drivers must comply with the signal quality specifications.
 Leakage to V_{SS} with land held at V_{TT}.
 Leakage to V_{TT} with land held at 300 mV

Table 12. **Open Drain and TAP Output Signal Group DC Specifications**

Symbol	Parameter	Min	Max	Unit	Notes ¹
V _{OL}	Output Low Voltage	0	0.20	V	-
V _{OH}	Output High Voltage	V _{TT} – 0.05	V _{TT} + 0.05	V	2
I _{OL}	Output Low Current	16	50	mA	3
I _{LO}	Output Leakage Current	N/A	± 200	μΑ	4

NOTES:

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies.
- 2. V_{OH} is determined by the value of the external pull-up resister to V_{TT} . 3. Measured at V_{TT} * 0.2. 4. For Vin between 0 and V_{OH}



Table 13. **CMOS Signal Group DC Specifications**

Symbol	Parameter	Min	Max	Unit	Notes ¹
V _{IL}	Input Low Voltage	-0.10	V _{TT} * 0.30	V	2, 3
V _{IH}	Input High Voltage	V _{TT} * 0.70	V _{TT} + 0.10	V	4, 5, 3
V _{OL}	Output Low Voltage	-0.10	V _{TT} * 0.10	V	3
V _{OH}	Output High Voltage	0.90 * V _{TT}	V _{TT} + 0.10	V	6, 5, 3
I _{OL}	Output Low Current	1.70	4.70	mA	3, 7
I _{OH}	Output High Current	1.70	4.70	mA	3, 7
I _{LI}	Input Leakage Current	N/A	± 100	μΑ	8
I _{LO}	Output Leakage Current	N/A	± 100	μΑ	9

NOTES:

- Unless otherwise noted, all specifications in this table apply to all processor frequencies. V_{IL} is defined as the voltage range at a receiving agent that will be interpreted as a logical low value.
- The V_{TT} referred to in these specifications refers to instantaneous V_{TT}.
 V_{IḤ} is defined as the voltage range at a receiving agent that will be interpreted as a logical high
- V_{IH} and V_{OH} may experience excursions above V_{TT}. However, input signal drivers must comply with the signal quality specifications.
- 6. All outputs are open drain.
 7. I_{OL} is measured at 0.10 * V_{TT}, I_{OH} is measured at 0.90 * V_{TT}.
 8. Leakage to V_{SS} with land held at V_{TT}.
 9. Leakage to V_{TT} with land held at 300 mV.

2.7.3.1 **GTL+ Front Side Bus Specifications**

In most cases, termination resistors are not required as these are integrated into the processor silicon. See Table 9 for details on which GTL+ signals do not include on-die

Valid high and low levels are determined by the input buffers by comparing with a reference voltage called GTLREF. Table 14 lists the GTLREF specifications. The GTL+ reference voltage (GTLREF) should be generated on the system board using high precision voltage divider circuits.



Table 14. **GTL+ Bus Voltage Definitions**

Symbol	Parameter	Min	Тур	Max	Units	Notes ¹
GTLREF_PU	GTLREF pull up resistor on Intel 975X and 96x Express Chipset family boards	124 * 0.99	124	124 * 1.01	Ω	2
GTLREF_PD	GTLREF pull down resistor on Intel 975X and 96x Express Chipset family boards	210 * 0.99	210	210 * 1.01	Ω	2
GTLREF_PU	GTLREF pull up resistor on Intel Series 3 Express Chipset family boards	100 * 0.99	100	100 * 1.01	Ω	2
GTLREF_PD	GTLREF pull down resistor on Intel Series 3 Express Chipset family boards	200 * 0.99	200	200 * 1.01	Ω	2
R _{TT}	Termination Resistance	45	50	55	Ω	3
COMP[3:0]	COMP Resistance	49.40	49.90	50.40	Ω	4
COMP8	COMP Resistance	24.65	24.90	25.15	Ω	4

- Unless otherwise noted, all specifications in this table apply to all processor frequencies.
 GTLREF is to be generated from V_{TT} by a voltage divider of 1% resistors (one divider for each GTLEREF land).
- 3. R_{TT} is the on-die termination resistance measured at $V_{TT}/3$ of the GTL+ output driver.
- 4. COMP resistance must be provided on the system board with 1% resistors. COMP[3:0] and COMP8 resistors are to V_{SS} .



2.8 Clock Specifications

2.8.1 Front Side Bus Clock (BCLK[1:0]) and Processor Clocking

BCLK[1:0] directly controls the FSB interface speed as well as the core frequency of the processor. As in previous generation processors, the processor's core frequency is a multiple of the BCLK[1:0] frequency. The processor bus ratio multiplier will be set at its default ratio during manufacturing. Refer to Table 15 for the processor supported ratios.

The processor uses a differential clocking implementation. For more information on the processor clocking, contact your Intel field representative. Platforms using a CK505 Clock Synthesizer/Driver should comply with the specifications in Section 2.8.4. Platforms using a CK410 Clock Synthesizer/Driver should comply with the specifications in Section 2.8.5.

Table 15. Core Frequency to FSB Multiplier Configuration

Multiplication of System Core Frequency to FSB Frequency	Core Frequency (200 MHz BCLK/800 MHz FSB)	Notes ^{1, 2}
1/6	1.20 GHz	-
1/7	1.40 GHz	-
1/8	1.60 GHz	-
1/9	1.80 GHz	-
1/10	2 GHz	-
1/11	2.2 GHz	-
1/12	2.4 GHz	-

NOTES

- 1. Individual processors operate only at or below the rated frequency.
- 2. Listed frequencies are not necessarily committed production frequencies.

2.8.2 FSB Frequency Select Signals (BSEL[2:0])

The BSEL[2:0] signals are used to select the frequency of the processor input clock (BCLK[1:0]). Table 16 defines the possible combinations of the signals and the frequency associated with each combination. The required frequency is determined by the processor, chipset, and clock synthesizer. All agents must operate at the same frequency.

The Intel Pentium Dual-Core Desktop processor E2000 series operates at a 800 MHz FSB frequency (selected by a 200 MHz BCLK[1:0] frequency).



BSEL[2:0] Frequency Table for BCLK[1:0] Table 16.

BSEL2	BSEL1	BSELO	FSB Frequency
L	L	L	RESERVED
L	L	Н	RESERVED
L	Н	Н	RESERVED
L	Н	L	200 MHz
Н	Н	L	RESERVED
Н	Н	Н	RESERVED
Н	L	Н	RESERVED
Н	L	L	RESERVED

2.8.3 Phase Lock Loop (PLL) and Filter

An on-die PLL filter solution will be implemented on the processor. The VCCPLL input is used for the PLL. Refer to Table 5 for DC specifications.

2.8.4 BCLK[1:0] Specifications (CK505 based Platforms)

Table 17. Front Side Bus Differential BCLK Specifications

Symbol	Parameter	Min	Тур	Max	Unit	Figure	Notes ¹
V _L	Input Low Voltage	-0.30	N/A	N/A	V	3	2
V _H	Input High Voltage	N/A	N/A	1.15	V	3	2
V _{CROSS(abs)}	Absolute Crossing Point	0.300	N/A	0.550	V	3, 4	3,45
ΔV_{CROSS}	Range of Crossing Points	N/A	N/A	0.140	V	3, 4	4
V _{OS}	Overshoot	N/A	N/A	1.4	V	3	6
V _{US}	Undershoot	-0.300	N/A	N/A	V	3	6
V _{SWING}	Differential Output Swing	0.300	N/A	N/A	V	5	7
I _{LI}	Input Leakage Current	-5	N/A	5	μΑ		
Cpad	Pad Capacitance	.95	1.2	1.45	pF		8

- Unless otherwise noted, all specifications in this table apply to all processor frequencies.
 "Steady state" voltage, not including overshoot or undershoot.
 Crossing voltage is defined as the instantaneous voltage value when the rising edge of BCLKO
- equals the falling edge of BCLK1.

 V_{Havg} is the statistical average of the V_H measured by the oscilloscope.

 The crossing point must meet the absolute and relative crossing point specifications simultaneously.
- Overshoot is defined as the absolute value of the maximum voltage. Undershoot is defined as the absolute value of the minimum voltage.
- 7. Measurement taken from differential waveform.
- 8. Cpad includes die capacitance only. No package parasitics are included.



Figure 3. Differential Clock Waveform

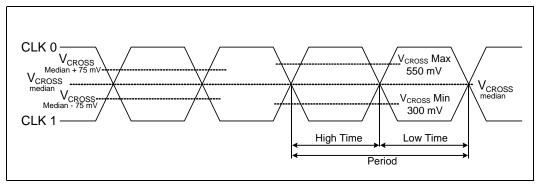


Figure 4. Differential Clock Crosspoint Specification

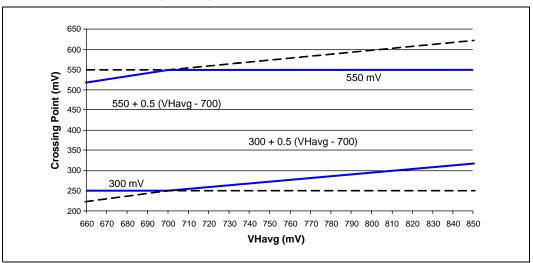
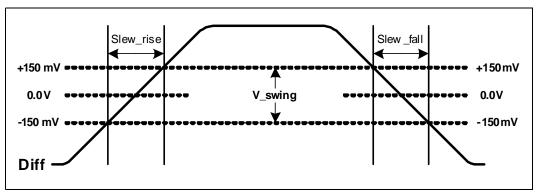


Figure 5. Differential Measurements





2.8.5 BCLK[1:0] Specifications (CK410 based Platforms)

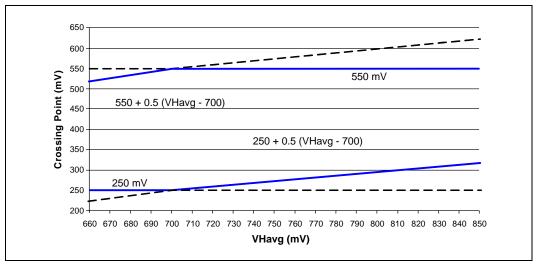
Table 18. Front Side Bus Differential BCLK Specifications

Symbol	Parameter	Min	Тур	Max	Unit	Figure	Notes ¹
V _L	Input Low Voltage	-0.150	0.00	N/A	V	3	-
V _H	Input High Voltage	0.660	0.70 0	0.850	V	3	-
V _{CROSS(abs)}	Absolute Crossing Point	0.250	N/A	0.550	V	3, 4	2, 3
V _{CROSS(rel)}	Relative Crossing Point	0.250 + 0.5(V _{Havg} - 0.700)	N/A	0.550 + 0.5(V _{Havg} - 0.700)	V	3, 4	4, 3, 5
ΔV _{CROSS}	Range of Crossing Points	N/A	N/A	0.140	V	3, 4	-
V _{OS}	Overshoot	N/A	N/A	V _H + 0.3	V	3	6
V _{US}	Undershoot	-0.300	N/A	N/A	V	3	7
V _{RBM}	Ringback Margin	0.200	N/A	N/A	V	3	8
V _{TM}	Threshold Region	V _{CROSS} – 0.100	N/A	V _{CROSS} + 0.100	V	3	9

NOTES:

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies.
- Crossing voltage is defined as the instantaneous voltage value when the rising edge of BCLKO equals the falling edge of BCLK1.
- The crossing point must meet the absolute and relative crossing point specifications simultaneously.
- V_{Havg} is the statistical average of the V_H measured by the oscilloscope. V_{Havg} can be measured directly using "Vtop" on Agilent* oscilloscopes and "High" on Tektronix* oscilloscopes. vershoot is defined as the absolute value of the maximum voltage.
- Undershoot is defined as the absolute value of the minimum voltage.
- Ringback Margin is defined as the absolute voltage difference between the maximum Rising Edge Ringback and the maximum Falling Edge Ringback.
- Threshold Region is defined as a region entered around the crossing point voltage in which the differential receiver switches. It includes input threshold hysteresis.

Figure 6. **Differential Clock Crosspoint Specification**





PECI DC Specifications

PECI is an Intel proprietary one-wire interface that provides a communication channel between Intel processors (may also include chipset components in the future) and external thermal monitoring devices. The processor contains Digital Thermal Sensors (DTS) distributed throughout die. These sensors are implemented as analog-to-digital converters calibrated at the factory for reasonable accuracy to provide a digital representation of relative processor temperature. PECI provides an interface to relay the highest DTS temperature within a die to external management devices for thermal/ fan speed control. More detailed information is available in the Platform Environment Control Interface (PECI) Specification.

Table 19. **PECI DC Electrical Limits**

Symbol	Definition and Conditions	Min	Max	Units	Notes ¹
V _{in}	Input Voltage Range	-0.15	V _{TT}	V	
V _{hysteresis}	Hysteresis	0.1 * V _{TT}	_	V	2
V _n	Negative-edge threshold voltage	0.275 * V _{TT}	0.500 * V _{TT}	V	
V _p	Positive-edge threshold voltage	0.550 * V _{TT}	0.762 * V _{TT}	V	
I _{source}	High level output source (V _{OH} = 0.75 * V _{TT)}	-6.0	N/A	mA	
I _{sink}	Low level output sink $(V_{OL} = 0.25 * V_{TT})$	0.5	1.0	mA	
I _{leak+}	High impedance state leakage to V_{TT}	N/A	50	μΑ	3
I _{leak-}	High impedance leakage to GND	N/A	10	μA	3
C _{bus}	Bus capacitance per node	N/A	10	pF	4
V _{noise}	Signal noise immunity above 300 MHz	0.1 * V _{TT}	_	V _{p-p}	

NOTES:

- V_T supplies the PECI interface. PECI behavior does not affect V_T min/max specifications. Refer to Table 4 for V_T specifications.
 The input buffers use a Schmitt-triggered input design for improved noise immunity.
- 3. The leakage specification applies to powered devices on the PECI bus.
- 4. One node is counted for each client and one node for the system host. Extended trace lengths might appear as additional nodes.

5 5



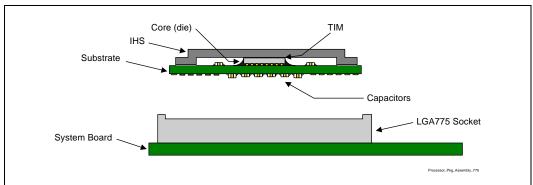
3 Package Mechanical Specifications

The processor is packaged in a Flip-Chip Land Grid Array (FC-LGA6) package that interfaces with the motherboard via an LGA775 socket. The package consists of a processor core mounted on a substrate land-carrier. An integrated heat spreader (IHS) is attached to the package substrate and core and serves as the mating surface for processor component thermal solutions, such as a heatsink. Figure 7 shows a sketch of the processor package components and how they are assembled together. Refer to the LGA775 Socket Mechanical Design Guide for complete details on the LGA775 socket.

The package components shown in Figure 7 include the following:

- Integrated Heat Spreader (IHS)
- Thermal Interface Material (TIM)
- Processor core (die)
- · Package substrate
- · Capacitors

Figure 7. Processor Package Assembly Sketch



NOTE:

1. Socket and system board are included for reference and are not part of processor package.

3.1 Package Mechanical Drawing

The package mechanical drawings are shown in Figure 8 and Figure 9. The drawings include dimensions necessary to design a thermal solution for the processor. These dimensions include:

- Package reference with tolerances (total height, length, width, etc.)
- · IHS parallelism and tilt
- Land dimensions
- Top-side and back-side component keep-out dimensions
- · Reference datums
- All drawing dimensions are in mm [in].
- Guidelines on potential IHS flatness variation with socket load plate actuation and installation of the cooling solution is available in the processor Thermal and Mechanical Design Guidelines (see Section 1.2).



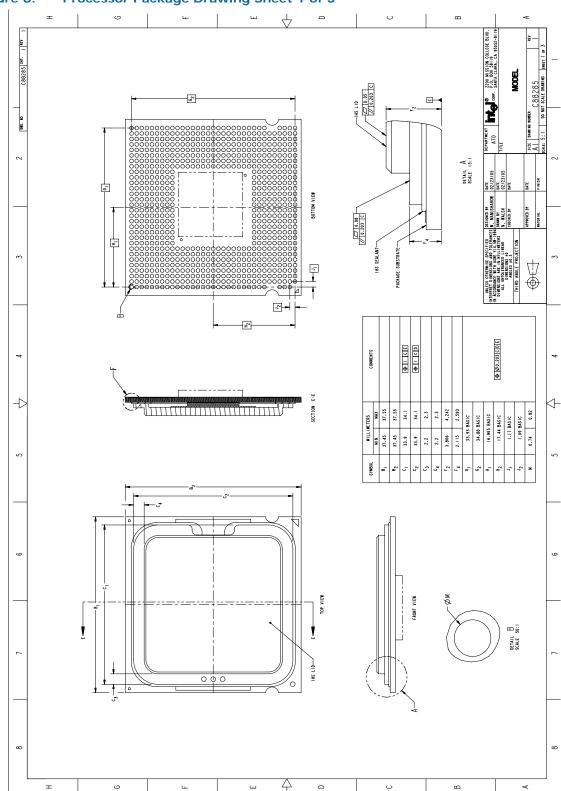


Figure 8. Processor Package Drawing Sheet 1 of 3



Figure 9. Processor Package Drawing Sheet 2 of 3

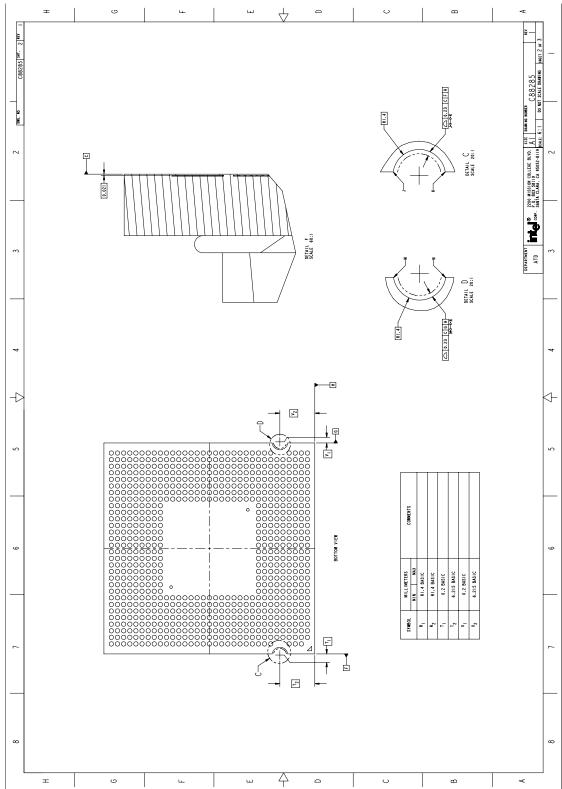
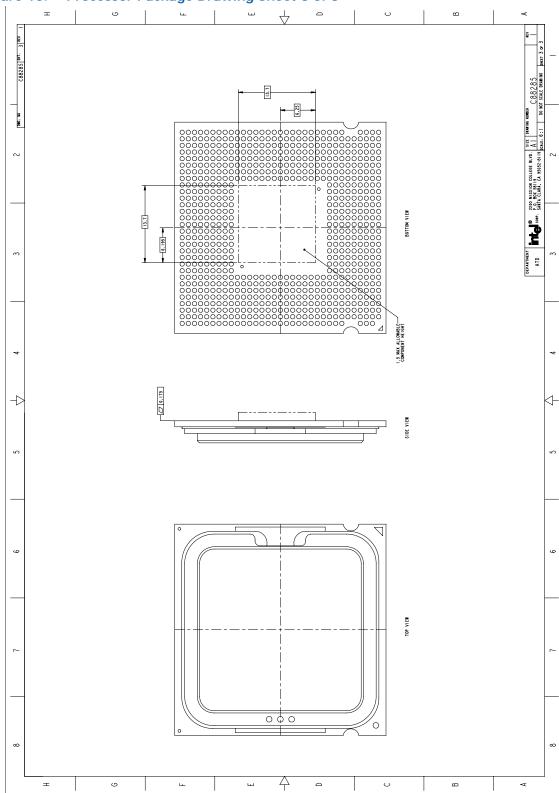




Figure 10. Processor Package Drawing Sheet 3 of 3





3.2 Processor Component Keep-Out Zones

The processor may contain components on the substrate that define component keepout zone requirements. A thermal and mechanical solution design must not intrude into the required keep-out zones. Decoupling capacitors are typically mounted to either the topside or land-side of the package substrate. See Figure 8 and Figure 9 for keep-out zones. The location and quantity of package capacitors may change due to manufacturing efficiencies but will remain within the component keep-in.

3.3 Package Loading Specifications

Table 20 provides dynamic and static load specifications for the processor package. These mechanical maximum load limits should not be exceeded during heatsink assembly, shipping conditions, or standard use condition. Also, any mechanical system or component testing should not exceed the maximum limits. The processor package substrate should not be used as a mechanical reference or load-bearing surface for thermal and mechanical solution. The minimum loading specification must be maintained by any thermal and mechanical solutions.

Table 20. Processor Loading Specifications

Parameter	Minimum	Maximum	Notes
Static	80 N [17 lbf]	311 N [70 lbf]	1, 2, 3
Dynamic	_	756 N [170 lbf]	1, 3, 4

NOTES:

- These specifications apply to uniform compressive loading in a direction normal to the processor IHS.
 This is the maximum force that can be applied by a heatsink retention clip. The clip must also
- This is the maximum force that can be applied by a heatsink retention clip. The clip must also provide the minimum specified load on the processor package.
 These specifications are based on limited testing for design characterization. Loading limits are
- These specifications are based on limited testing for design characterization. Loading limits are for the package only and do not include the limits of the processor socket.
 Dynamic loading is defined as an 11 ms duration average load superimposed on the static load
- Dynamic loading is defined as an 11 ms duration average load superimposed on the static load requirement.

3.4 Package Handling Guidelines

Table 21 includes a list of guidelines on package handling in terms of recommended maximum loading on the processor IHS relative to a fixed substrate. These package handling loads may be experienced during heatsink removal.

Table 21. Package Handling Guidelines

Parameter	Maximum Recommended	Notes
Shear	311 N [70 lbf]	1, 2
Tensile	111 N [25 lbf]	2, 3
Torque	3.95 N-m [35 lbf-in]	2, 4

NOTES

- 1. A shear load is defined as a load applied to the IHS in a direction parallel to the IHS top surface.
- These guidelines are based on limited testing for design characterization.
- A tensile load is defined as a pulling load applied to the IHS in a direction normal to the IHS surface.
- 4. A torque load is defined as a twisting load applied to the IHS in an axis of rotation normal to the IHS top surface.



3.5 Package Insertion Specifications

The processor can be inserted into and removed from a LGA775 socket 15 times. The socket should meet the LGA775 requirements detailed in the *LGA775 Socket Mechanical Design Guide*.

3.6 Processor Mass Specification

The typical mass of the processor is 21.5 g [0.76 oz]. This mass [weight] includes all the components that are included in the package.

3.7 Processor Materials

Table 22 lists some of the package components and associated materials.

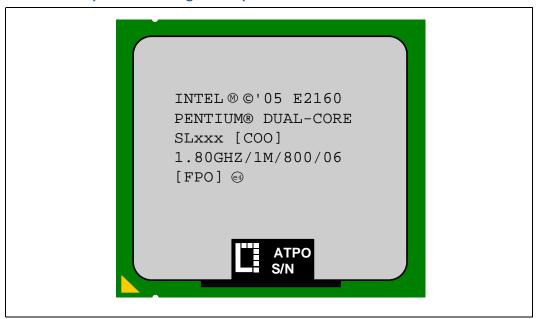
Table 22. Processor Materials

Component	Material		
Integrated Heat Spreader (IHS)	Nickel Plated Copper		
Substrate	Fiber Reinforced Resin		
Substrate Lands	Gold Plated Copper		

3.8 Processor Markings

Figure 11 shows the topside markings on the processors. This diagram aids in the identification of the processor.

Figure 11. Processor Top-Side Markings Example

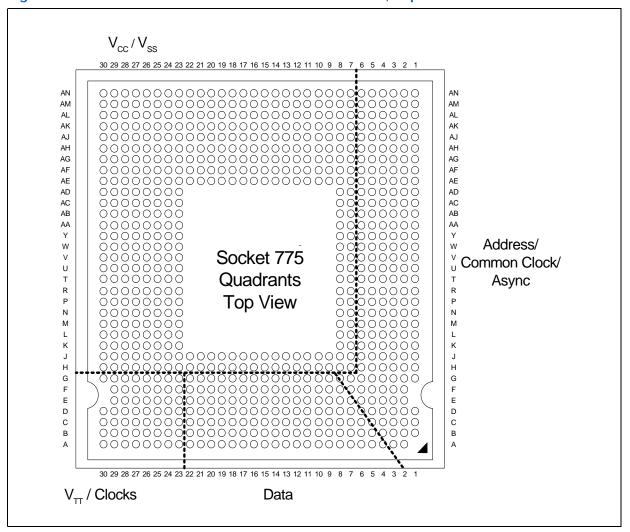




3.9 Processor Land Coordinates

Figure 12 shows the top view of the processor land coordinates. The coordinates are referred to throughout the document to identify processor lands.

Figure 12. Processor Land Coordinates and Quadrants, Top View



§ §





4 Land Listing and Signal Descriptions

This chapter provides the processor land assignment and signal descriptions.

4.1 Processor Land Assignments

This section contains the land listings for the processor. The land-out footprint is shown in Figure 13 and Figure 14. These figures represent the land-out arranged by land number and they show the physical location of each signal on the package land array (top view). Table 23 provides a list of processor lands ordered alphabetically by land (signal) name. Table 24 provides a list of processor lands ordered by land number.



Figure 13. land-out Diagram (Top View – Left Side)

	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16	15
AN	vcc	VCC	VSS	VSS	VCC	vcc	VSS	VSS	VCC	VCC	VSS	vcc	VCC	VSS	VSS	vcc
AM	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AL	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AK	VSS	VSS	VSS	VSS	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AJ	VSS	VSS	VSS	VSS	VCC	VCC	VSS	VSS	VCC	VCC	VSS	vcc	VCC	VSS	VSS	VCC
АН	VCC	VCC	VCC	VCC	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AG	VCC	VCC	VCC	VCC	VCC	VCC	VSS	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AF	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AE	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VCC	VCC	VCC	VSS	VCC	VCC	VSS	VSS	VCC
AD	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
AC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
AB	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS								
AA	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS								
Υ	VCC	VCC	VCC	VCC	VCC	vcc	VCC	VCC								
w	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
v	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS								
U	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
Т	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
R	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS								
Р	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS								
N	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
М	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
L	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS								
K	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC								
J	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	VCC	FC34	FC31	VCC
н	BSEL1	FC15	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	FC33	FC32
G	BSEL2	BSEL0	BCLK1	TESTHI4	TESTHI5	TESTHI3	TESTHI6	RESET#	D47#	D44#	DSTBN2#	DSTBP2#	D35#	D36#	D32#	D31#
F		RSVD	BCLKO	VTT_SEL	TESTHI0	TESTHI2	TESTHI7	RSVD	VSS	D43#	D41#	VSS	D38#	D37#	VSS	D30#
E		FC26	VSS	VSS	VSS	VSS	FC10	RSVD	D45#	D42#	VSS	D40#	D39#	VSS	D34#	D33#
D	VTT	VTT	VTT	VTT	VTT	VTT	VSS	VCCPLL	D46#	VSS	D48#	DBI2#	VSS	D49#	RSVD	VSS
С	VTT	VTT	VTT	VTT	VTT	VTT	VSS	VCCIO PLL	VSS	D58#	DBI3#	VSS	D54#	DSTBP3#	VSS	D51#
В	VTT	VTT	VTT	VTT	VTT	VTT	VSS	VSSA	D63#	D59#	VSS	D60#	D57#	VSS	D55#	D53#
Α	VTT	VTT	VTT	VTT	VTT	VTT	FC23	VCCA	D62#	VSS	RSVD	D61#	VSS	D56#	DSTBN3#	VSS
	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16	15



Figure 14. land-out Diagram (Top View – Right Side)

14	13	12	11	10	9	8	7	6	5	4	3	2	1	
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VID_SELE CT	VSS_MB_ REGULATION	VCC_MB_ REGULATION	VSS_ SENSE	VCC_ SENSE	VSS	VSS	AN
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VID7	FC40	VID6	VSS	VID2	VIDO	VSS	AM
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VID3	VID1	VID5	VRDSEL	PROCHOT#	THERMDA	AL
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VSS	FC8	VSS	VID4	ITP_CLK0	VSS	THERMDC	AK
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VSS	A35#	A34#	VSS	ITP_CLK1	BPM0#	BPM1#	AJ
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	A33#	A32#	VSS	RSVD	VSS	АН
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VSS	A29#	A31#	A30#	BPM5#	BPM3#	TRST#	AG
VCC	VSS	VCC	VCC	VSS	VCC	VCC	VSS	VSS	A27#	A28#	VSS	BPM4#	TDO	AF
VCC	VSS	VCC	VCC	VSS	VCC	SKTOCC#	VSS	RSVD	VSS	RSVD	FC18	VSS	TCK	AE
						VCC	VSS	A22#	ADSTB1#	VSS	FC36	BPM2#	TDI	AD
						VCC	VSS	VSS	A25#	RSVD	VSS	DBR#	TMS	AC
						VCC	VSS	A17#	A24#	A26#	FC37	IERR#	VSS	AB
						vcc	VSS	vss	A23#	A21#	VSS	FC39	VTT_OUT_ RIGHT	AA
						VCC	VSS	A19#	VSS	A20#	FC17	VSS	FC0	Υ
						VCC	VSS	A18#	A16#	VSS	TESTHI1	TESTHI12/ FC44	MSID0	w
						VCC	VSS	VSS	A14#	A15#	VSS	RSVD	MSID1	V
						VCC	VSS	A10#	A12#	A13#	FC30	FC29	FC28	U
						VCC	VSS	VSS	A9#	A11#	VSS	FC4	COMP1	Т
						VCC	VSS	ADSTB0#	VSS	A8#	FERR#/ PBE#	VSS	COMP3	R
						VCC	VSS	A4#	RSVD	VSS	INIT#	SMI#	TESTHI11	Р
						VCC	VSS	VSS	RSVD	RSVD	VSS	IGNNE#	PWRGOOD	N
						VCC	VSS	REQ2#	A 5#	A7#	STPCLK#	THERMTRIP#	VSS	М
						VCC	VSS	VSS	A3#	A6#	VSS	TESTHI13	LINT1	L
						VCC	VSS	REQ3#	VSS	REQ0#	A20M#	VSS	LINTO	K
VCC	vcc	VCC	VCC	VCC	vcc	vcc	VSS	REQ4#	REQ1#	VSS	FC22	FC3	VTT_OUT_ LEFT	J
VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	TESTHI10	FC35	VSS	GTLREF1	GTLREFO	Н
D29#	D27#	DSTBN1#	DBI1#	FC38	D16#	BPRI#	DEFER#	RSVD	PECI	TESTHI9/ FC43	TESTHI8/ FC42	COMP2	FC27	G
D28#	VSS	D24#	D23#	VSS	D18#	D17#	VSS	FC21	RS1#	VSS	BRO#	FC5		F
VSS	D26#	DSTBP1#	VSS	D21#	D19#	VSS	RSVD	RSVD	FC20	HITM#	TRDY#	VSS		E
RSVD	D25#	VSS	D15#	D22#	VSS	D12#	D20#	VSS	VSS	HIT#	VSS	ADS#	RSVD	D
D52#	VSS	D14#	D11#	VSS	FC38	DSTBN0#	VSS	D3#	D1#	VSS	LOCK#	BNR#	DRDY#	С
VSS	COMP8	D13#	VSS	D10#	DSTBP0#	VSS	D6#	D5#	VSS	D0#	RS0#	DBSY#	VSS	В
D50#	COMPO	VSS	D9#	D8#	VSS	DBIO#	D7#	VSS	D4#	D2#	RS2#	VSS		А
14	13	12	11	10	9	8	7	6	5	4	3	2	1	-



Table 23. Alphabetical Land Assignments

Signal Buffer Land **Land Name** Direction Type A3# L5 Input/Output Source Synch P6 Input/Output A4# Source Synch A5# M5 Source Synch Input/Output Source Synch Input/Output A6# L4 A7# M4 Input/Output Source Synch Input/Output A8# R4 Source Synch Input/Output A9# T5 Source Synch A10# U6 Input/Output Source Synch T4 Input/Output Source Synch A11# A12# U5 Input/Output Source Synch U4 Input/Output A13# Source Synch V5 A14# Input/Output Source Synch A15# ٧4 Source Synch Input/Output A16# W5 Source Synch Input/Output AB6 Input/Output A17# Source Synch A18# W6 Source Synch Input/Output A19# Input/Output Υ6 Source Synch Input/Output A20# Υ4 Source Synch A20M# К3 Asynch CMOS Input A21# AA4 Input/Output Source Synch A22# AD6 Input/Output Source Synch A23# AA5 Source Synch Input/Output A24# AB5 Input/Output Source Synch A25# AC5 Source Synch Input/Output AB4 A26# Source Synch Input/Output A27# AF5 Source Synch Input/Output A28# AF4 Input/Output Source Synch Input/Output A29# AG6 Source Synch A30# AG4 Source Synch Input/Output A31# AG5 Input/Output Source Synch AH4 Input/Output A32# Source Synch Input/Output AH5 A33# Source Synch A34# AJ5 Source Synch Input/Output A35# AJ6 Input/Output Source Synch ADS# D2 Input/Output Common Clock ADSTB0# R6 Source Synch Input/Output ADSTB1# AD5 Input/Output Source Synch BCLK0 F28 Clock Input G28 BCLK1 Clock Input

Table 23. Alphabetical Land Assignments

		_	
Land Name	Land #	Signal Buffer Type	Direction
BNR#	C2	Common Clock	Input/Output
BPMO#	AJ2	Common Clock	Input/Output
BPM1#	AJ1	Common Clock	Input/Output
BPM2#	AD2	Common Clock	Input/Output
BPM3#	AG2	Common Clock	Input/Output
BPM4#	AF2	Common Clock	Input/Output
BPM5#	AG3	Common Clock	Input/Output
BPRI#	G8	Common Clock	Input
BR0#	F3	Common Clock	Input/Output
BSEL0	G29	Power/Other	Output
BSEL1	H30	Power/Other	Output
BSEL2	G30	Power/Other	Output
СОМРО	A13	Power/Other	Input
COMP1	T1	Power/Other	Input
COMP2	G2	Power/Other	Input
COMP3	R1	Power/Other	Input
COMP8	B13	Power/Other	Input
D0#	B4	Source Synch	Input/Output
D1#	C5	Source Synch	Input/Output
D2#	A4	Source Synch	Input/Output
D3#	C6	Source Synch	Input/Output
D4#	A 5	Source Synch	Input/Output
D5#	В6	Source Synch	Input/Output
D6#	В7	Source Synch	Input/Output
D7#	A7	Source Synch	Input/Output
D8#	A10	Source Synch	Input/Output
D9#	A11	Source Synch	Input/Output
D10#	B10	Source Synch	Input/Output
D11#	C11	Source Synch	Input/Output
D12#	D8	Source Synch	Input/Output
D13#	B12	Source Synch	Input/Output
D14#	C12	Source Synch	Input/Output
D15#	D11	Source Synch	Input/Output
D16#	G9	Source Synch	Input/Output
D17#	F8	Source Synch	Input/Output
D18#	F9	Source Synch	Input/Output
D19#	E9	Source Synch	Input/Output
D20#	D7	Source Synch	Input/Output
D21#	E10	Source Synch	Input/Output



Table 23. Alphabetical Land Assignments

Land Signal Buffer **Land Name** Direction **Type** D22# D10 Source Synch Input/Output D23# F11 Input/Output Source Synch D24# F12 Input/Output Source Synch D25# D13 Input/Output Source Synch D26# E13 Source Synch Input/Output D27# G13 Source Synch Input/Output D28# F14 Source Synch Input/Output D29# G14 Source Synch Input/Output D30# F15 Input/Output Source Synch D31# G15 Source Synch Input/Output D32# G16 Input/Output Source Synch D33# E15 Input/Output Source Synch D34# E16 Source Synch Input/Output D35# G18 Input/Output Source Synch D36# G17 Input/Output Source Synch D37# F17 Input/Output Source Synch D38# F18 Source Synch Input/Output D39# Input/Output E18 Source Synch D40# E19 Input/Output Source Synch D41# F20 Source Synch Input/Output D42# E21 Source Synch Input/Output D43# F21 Input/Output Source Synch D44# G21 Input/Output Source Synch D45# E22 Source Synch Input/Output D46# D22 Input/Output Source Synch D47# G22 Input/Output Source Synch D48# D20 Source Synch Input/Output D49# D17 Source Synch Input/Output D50# A14 Input/Output Source Synch D51# C15 Source Synch Input/Output D52# C14 Source Synch Input/Output D53# B15 Input/Output Source Synch D54# C18 Source Synch Input/Output D55# B16 Source Synch Input/Output D56# A17 Source Synch Input/Output D57# B18 Input/Output Source Synch D58# C21 Source Synch Input/Output D59# B21 Source Synch Input/Output D60# B19 Source Synch Input/Output

Table 23. Alphabetical Land Assignments

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Land Name	Land #	Signal Buffer Type	Direction
D61#	A19	Source Synch	Input/Output
D62#	A22	Source Synch	Input/Output
D63#	B22	Source Synch	Input/Output
DBIO#	A8	Source Synch	Input/Output
DBI1#	G11	Source Synch	Input/Output
DBI2#	D19	Source Synch	Input/Output
DBI3#	C20	Source Synch	Input/Output
DBR#	AC2	Power/Other	Output
DBSY#	B2	Common Clock	Input/Output
DEFER#	G7	Common Clock	Input
DRDY#	C1	Common Clock	Input/Output
DSTBN0#	C8	Source Synch	Input/Output
DSTBN1#	G12	Source Synch	Input/Output
DSTBN2#	G20	Source Synch	Input/Output
DSTBN3#	A16	Source Synch	Input/Output
DSTBP0#	В9	Source Synch	Input/Output
DSTBP1#	E12	Source Synch	Input/Output
DSTBP2#	G19	Source Synch	Input/Output
DSTBP3#	C17	Source Synch	Input/Output
FC0	Y1	Power/Other	
FC3	J2	Power/Other	
FC4	T2	Power/Other	
FC5	F2	Power/Other	
FC8	AK6	Power/Other	
FC10	E24	Power/Other	
FC15	H29	Power/Other	
FC17	Y3	Power/Other	
FC18	AE3	Power/Other	
FC20	E5	Power/Other	
FC21	F6	Power/Other	
FC22	J3	Power/Other	
FC23	A24	Power/Other	
FC26	E29	Power/Other	
FC27	G1	Power/Other	
FC28	U1	Power/Other	
FC29	U2	Power/Other	
FC30	U3	Power/Other	
FC31	J16	Power/Other	
FC32	H15	Power/Other	



Table 23. Alphabetical Land Assignments

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Land Name	Land #	Signal Buffer Type	Direction
FC33	H16	Power/Other	
FC34	J17	Power/Other	
FC35	H4	Power/Other	
FC36	AD3	Power/Other	
FC37	AB3	Power/Other	
FC38	G10	Power/Other	
FC38	C9	Power/Other	
FC39	AA2	Power/Other	
FC40	AM6	Power/Other	
FERR#/PBE#	R3	Asynch CMOS	Output
GTLREF0	H1	Power/Other	Input
GTLREF1	H2	Power/Other	Input
HIT#	D4	Common Clock	Input/Output
HITM#	E4	Common Clock	Input/Output
IERR#	AB2	Asynch CMOS	Output
IGNNE#	N2	Asynch CMOS	Input
INIT#	P3	Asynch CMOS	Input
ITP_CLK0	AK3	TAP	Input
ITP_CLK1	AJ3	TAP	Input
LINTO	K1	Asynch CMOS	Input
LINT1	L1	Asynch CMOS	Input
LOCK#	C3	Common Clock	Input/Output
MSID0	W1	Power/Other	Output
MSID1	V1	Power/Other	Output
PECI	G5	Power/Other	Input/Output
PROCHOT#	AL2	Asynch CMOS	Input/Output
PWRGOOD	N1	Power/Other	Input
REQ0#	K4	Source Synch	Input/Output
REQ1#	J5	Source Synch	Input/Output
REQ2#	M6	Source Synch	Input/Output
REQ3#	K6	Source Synch	Input/Output
REQ4#	J6	Source Synch	Input/Output
RESERVED	A20		
RESERVED	AC4		
RESERVED	AE4		
RESERVED	AE6		
RESERVED	AH2		
RESERVED	D1		
RESERVED	D14		
L		ı	

Table 23. Alphabetical Land Assignments

Land Name	on
DECEDIED FOO	
RESERVED E23	
RESERVED E6	
RESERVED E7	
RESERVED F23	
RESERVED F29	
RESERVED G6	
RESERVED N4	
RESERVED N5	
RESERVED P5	
RESERVED V2	
RESET# G23 Common Clock Input	
RS0# B3 Common Clock Input	
RS1# F5 Common Clock Input	
RS2# A3 Common Clock Input	
SKTOCC# AE8 Power/Other Outpu	t
SMI# P2 Asynch CMOS Input	
STPCLK# M3 Asynch CMOS Input	
TCK AE1 TAP Input	
TDI AD1 TAP Input	
TDO AF1 TAP Outpu	t
TESTHIO F26 Power/Other Input	
TESTHI1 W3 Power/Other Input	
TESTHI10 H5 Power/Other Input	
TESTHI11 P1 Power/Other Input	
TESTHI12/ FC44 W2 Power/Other Input	
TESTHI13 L2 Power/Other Input	
TESTHI2 F25 Power/Other Input	
TESTHI3 G25 Power/Other Input	
TESTHI4 G27 Power/Other Input	
TESTHI5 G26 Power/Other Input	
TESTHI6 G24 Power/Other Input	
TESTHI7 F24 Power/Other Input	
TESTHI8/FC42 G3 Power/Other Input	
TESTHI9/FC43 G4 Power/Other Input	
THERMDA AL1 Power/Other	
THERMDC AK1 Power/Other	
THERMTRIP# M2 Asynch CMOS Outpu	t
TMS AC1 TAP Input	



Table 23. Alphabetical Land Assignments

Land Signal Buffer **Land Name Direction** Type TRDY# E3 Common Clock Input TRST# TAP AG1 Input VCC AA8 Power/Other VCC AB8 Power/Other VCC AC23 Power/Other VCC AC24 Power/Other VCC AC25 Power/Other VCC AC26 Power/Other Power/Other VCC AC27 VCC AC28 Power/Other VCC AC29 Power/Other VCC AC30 Power/Other VCC AC8 Power/Other VCC AD23 Power/Other VCC AD24 Power/Other VCC AD25 Power/Other VCC AD26 Power/Other VCC AD27 Power/Other VCC AD28 Power/Other VCC AD29 Power/Other Power/Other VCC AD30 VCC AD8 Power/Other VCC AE11 Power/Other VCC AE12 Power/Other VCC AE14 Power/Other VCC AE15 Power/Other VCC AE18 Power/Other VCC AE19 Power/Other VCC AE21 Power/Other VCC AE22 Power/Other VCC AE23 Power/Other VCC AE9 Power/Other VCC AF11 Power/Other VCC AF12 Power/Other VCC AF14 Power/Other VCC AF15 Power/Other VCC AF18 Power/Other VCC AF19 Power/Other VCC AF21 Power/Other

Table 23. Alphabetical Land Assignments

Assignments							
Land Name	Land #	Signal Buffer Type	Direction				
VCC	AF22	Power/Other					
VCC	AF8	Power/Other					
VCC	AF9	Power/Other					
VCC	AG11	Power/Other					
VCC	AG12	Power/Other					
VCC	AG14	Power/Other					
VCC	AG15	Power/Other					
VCC	AG18	Power/Other					
VCC	AG19	Power/Other					
VCC	AG21	Power/Other					
VCC	AG22	Power/Other					
VCC	AG25	Power/Other					
VCC	AG26	Power/Other					
VCC	AG27	Power/Other					
VCC	AG28	Power/Other					
VCC	AG29	Power/Other					
VCC	AG30	Power/Other					
VCC	AG8	Power/Other					
VCC	AG9	Power/Other					
VCC	AH11	Power/Other					
VCC	AH12	Power/Other					
VCC	AH14	Power/Other					
VCC	AH15	Power/Other					
VCC	AH18	Power/Other					
VCC	AH19	Power/Other					
VCC	AH21	Power/Other					
VCC	AH22	Power/Other					
VCC	AH25	Power/Other					
VCC	AH26	Power/Other					
VCC	AH27	Power/Other					
VCC	AH28	Power/Other					
VCC	AH29	Power/Other					
VCC	AH30	Power/Other					
VCC	AH8	Power/Other					
VCC	AH9	Power/Other					
VCC	AJ11	Power/Other					
VCC	AJ12	Power/Other					
VCC	AJ14	Power/Other					
VCC	AJ15	Power/Other					



Table 23. Alphabetical Land Assignments

Signal Buffer Land **Land Name** Direction Type VCC AJ18 Power/Other VCC AJ19 Power/Other VCC AJ21 Power/Other VCC AJ22 Power/Other VCC AJ25 Power/Other VCC AJ26 Power/Other Power/Other VCC AJ8 Power/Other VCC AJ9 VCC AK11 Power/Other VCC AK12 Power/Other Power/Other VCC AK14 AK15 VCC Power/Other VCC AK18 Power/Other VCC AK19 Power/Other VCC AK21 Power/Other VCC AK22 Power/Other VCC AK25 Power/Other VCC AK26 Power/Other VCC Power/Other AK8 VCC AK9 Power/Other VCC AL11 Power/Other VCC AL12 Power/Other VCC AL14 Power/Other VCC AL15 Power/Other VCC AL18 Power/Other VCC AL19 Power/Other VCC AL21 Power/Other VCC AL22 Power/Other VCC AL25 Power/Other VCC AL26 Power/Other VCC AL29 Power/Other Power/Other VCC AL30 VCC AL8 Power/Other VCC Power/Other AL9 AM11 VCC Power/Other VCC AM12 Power/Other VCC AM14 Power/Other VCC AM15 Power/Other VCC AM18 Power/Other

Table 23. Alphabetical Land Assignments

Land Name	Land #	Signal Buffer Type	Direction
VCC	AM19	Power/Other	
VCC	AM21	Power/Other	
VCC	AM22	Power/Other	
VCC	AM25	Power/Other	
VCC	AM26	Power/Other	
VCC	AM29	Power/Other	
VCC	AM30	Power/Other	
VCC	AM8	Power/Other	
VCC	AM9	Power/Other	
VCC	AN11	Power/Other	
VCC	AN12	Power/Other	
VCC	AN14	Power/Other	
VCC	AN15	Power/Other	
VCC	AN18	Power/Other	
VCC	AN19	Power/Other	
VCC	AN21	Power/Other	
VCC	AN22	Power/Other	
VCC	AN25	Power/Other	
VCC	AN26	Power/Other	
VCC	AN29	Power/Other	
VCC	AN30	Power/Other	
VCC	AN8	Power/Other	
VCC	AN9	Power/Other	
VCC	J10	Power/Other	
VCC	J11	Power/Other	
VCC	J12	Power/Other	
VCC	J13	Power/Other	
VCC	J14	Power/Other	
VCC	J15	Power/Other	
VCC	J18	Power/Other	
VCC	J19	Power/Other	
VCC	J20	Power/Other	
VCC	J21	Power/Other	
VCC	J22	Power/Other	
VCC	J23	Power/Other	
VCC	J24	Power/Other	
VCC	J25	Power/Other	
VCC	J26	Power/Other	
VCC	J27	Power/Other	



Table 23. Alphabetical Land Assignments

Land Signal Buffer **Land Name** Direction Туре VCC J28 Power/Other VCC J29 Power/Other VCC J30 Power/Other VCC J8 Power/Other VCC J9 Power/Other VCC K23 Power/Other VCC K24 Power/Other VCC K25 Power/Other VCC Power/Other K26 VCC K27 Power/Other VCC K28 Power/Other VCC K29 Power/Other VCC K30 Power/Other VCC Κ8 Power/Other VCC L8 Power/Other VCC M23 Power/Other VCC M24 Power/Other VCC M25 Power/Other VCC M26 Power/Other VCC M27 Power/Other VCC M28 Power/Other VCC M29 Power/Other VCC M30 Power/Other VCC M8 Power/Other VCC N23 Power/Other VCC N24 Power/Other VCC N25 Power/Other VCC N26 Power/Other VCC N27 Power/Other VCC N28 Power/Other VCC N29 Power/Other VCC N30 Power/Other VCC Ν8 Power/Other VCC Р8 Power/Other VCC R8 Power/Other VCC T23 Power/Other VCC T24 Power/Other VCC T25 Power/Other VCC T26 Power/Other

Table 23. Alphabetical Land Assignments

Land Name	Land #	Signal Buffer Type	Direction
VCC	T27	Power/Other	
VCC	T28	Power/Other	
VCC	T29	Power/Other	
VCC	T30	Power/Other	
VCC	T8	Power/Other	
VCC	U23	Power/Other	
VCC	U24	Power/Other	
VCC	U25	Power/Other	
VCC	U26	Power/Other	
VCC	U27	Power/Other	
VCC	U28	Power/Other	
VCC	U29	Power/Other	
VCC	U30	Power/Other	
VCC	U8	Power/Other	
VCC	V8	Power/Other	
VCC	W23	Power/Other	
VCC	W24	Power/Other	
VCC	W25	Power/Other	
VCC	W26	Power/Other	
VCC	W27	Power/Other	
VCC	W28	Power/Other	
VCC	W29	Power/Other	
VCC	W30	Power/Other	
VCC	W8	Power/Other	
VCC	Y23	Power/Other	
VCC	Y24	Power/Other	
VCC	Y25	Power/Other	
VCC	Y26	Power/Other	
VCC	Y27	Power/Other	
VCC	Y28	Power/Other	
VCC	Y29	Power/Other	
VCC	Y30	Power/Other	
VCC	Y8	Power/Other	
VCC_MB_ REGULATION	AN5	Power/Other	Output
VCC_SENSE	AN3	Power/Other	Output
VCCA	A23	Power/Other	
VCCIOPLL	C23	Power/Other	
VCCPLL	D23	Power/Other	
VID_SELECT	AN7	Power/Other	Output



Table 23. Alphabetical Land Assignments

Signal Buffer Land **Land Name** Direction Type Power/Other VIDO AM2 Output VID1 AL5 Power/Other Output VID2 AM3 Power/Other Output VID3 Power/Other AL6 Output VID4 AK4 Power/Other Output VID5 AL4 Power/Other Output Power/Other Output VID6 AM5 VID7 AM7 Power/Other Output VRDSEL AL3 Power/Other VSS A12 Power/Other Power/Other VSS A15 VSS A18 Power/Other VSS Α2 Power/Other VSS A21 Power/Other VSS Α6 Power/Other VSS Α9 Power/Other VSS AA23 Power/Other VSS AA24 Power/Other AA25 Power/Other VSS VSS AA26 Power/Other VSS AA27 Power/Other VSS AA28 Power/Other VSS **AA29** Power/Other VSS Power/Other AA3 VSS AA30 Power/Other VSS AA6 Power/Other VSS AA7 Power/Other VSS AB1 Power/Other VSS AB23 Power/Other VSS AB24 Power/Other VSS AB25 Power/Other Power/Other VSS AB26 VSS AB27 Power/Other AB28 Power/Other VSS AB29 VSS Power/Other VSS AB30 Power/Other VSS AB7 Power/Other VSS AC3 Power/Other VSS AC6 Power/Other

Table 23. Alphabetical Land Assignments

Land Name	Land #	Signal Buffer Type	Direction
VSS	AC7	Power/Other	
VSS	AD4	Power/Other	
VSS	AD7	Power/Other	
VSS	AE10	Power/Other	
VSS	AE13	Power/Other	
VSS	AE16	Power/Other	
VSS	AE17	Power/Other	
VSS	AE2	Power/Other	
VSS	AE20	Power/Other	
VSS	AE24	Power/Other	
VSS	AE25	Power/Other	
VSS	AE26	Power/Other	
VSS	AE27	Power/Other	-
VSS	AE28	Power/Other	
VSS	AE29	Power/Other	
VSS	AE30	Power/Other	
VSS	AE5	Power/Other	
VSS	AE7	Power/Other	
VSS	AF10	Power/Other	
VSS	AF13	Power/Other	
VSS	AF16	Power/Other	
VSS	AF17	Power/Other	
VSS	AF20	Power/Other	
VSS	AF23	Power/Other	
VSS	AF24	Power/Other	
VSS	AF25	Power/Other	
VSS	AF26	Power/Other	
VSS	AF27	Power/Other	
VSS	AF28	Power/Other	
VSS	AF29	Power/Other	
VSS	AF3	Power/Other	
VSS	AF30	Power/Other	
VSS	AF6	Power/Other	
VSS	AF7	Power/Other	
VSS	AG10	Power/Other	
VSS	AG13	Power/Other	
VSS	AG16	Power/Other	
VSS	AG17	Power/Other	
VSS	AG20	Power/Other	



Table 23. Alphabetical Land Assignments

Land Signal Buffer **Land Name** Direction Type VSS AG23 Power/Other VSS AG24 Power/Other VSS AG7 Power/Other VSS AH1 Power/Other VSS AH10 Power/Other VSS AH13 Power/Other VSS AH16 Power/Other VSS AH17 Power/Other VSS AH20 Power/Other VSS AH23 Power/Other VSS AH24 Power/Other VSS АН3 Power/Other VSS AH6 Power/Other VSS AH7 Power/Other VSS AJ10 Power/Other VSS AJ13 Power/Other VSS AJ16 Power/Other VSS AJ17 Power/Other VSS AJ20 Power/Other VSS AJ23 Power/Other VSS AJ24 Power/Other VSS AJ27 Power/Other VSS AJ28 Power/Other VSS AJ29 Power/Other VSS AJ30 Power/Other VSS AJ4 Power/Other VSS AJ7 Power/Other VSS AK10 Power/Other VSS AK13 Power/Other VSS AK16 Power/Other VSS AK17 Power/Other VSS AK2 Power/Other VSS AK20 Power/Other VSS AK23 Power/Other VSS AK24 Power/Other VSS AK27 Power/Other VSS AK28 Power/Other VSS AK29 Power/Other VSS AK30 Power/Other

Table 23. Alphabetical Land Assignments

Assignments			
Land Name	Land #	Signal Buffer Type	Direction
VSS	AK5	Power/Other	
VSS	AK7	Power/Other	
VSS	AL10	Power/Other	
VSS	AL13	Power/Other	
VSS	AL16	Power/Other	
VSS	AL17	Power/Other	
VSS	AL20	Power/Other	
VSS	AL23	Power/Other	
VSS	AL24	Power/Other	
VSS	AL27	Power/Other	
VSS	AL28	Power/Other	
VSS	AL7	Power/Other	
VSS	AM1	Power/Other	
VSS	AM10	Power/Other	
VSS	AM13	Power/Other	
VSS	AM16	Power/Other	
VSS	AM17	Power/Other	
VSS	AM20	Power/Other	
VSS	AM23	Power/Other	
VSS	AM24	Power/Other	
VSS	AM27	Power/Other	
VSS	AM28	Power/Other	
VSS	AM4	Power/Other	
VSS	AN1	Power/Other	
VSS	AN10	Power/Other	
VSS	AN13	Power/Other	
VSS	AN16	Power/Other	
VSS	AN17	Power/Other	
VSS	AN2	Power/Other	
VSS	AN20	Power/Other	
VSS	AN23	Power/Other	
VSS	AN24	Power/Other	
VSS	AN27	Power/Other	
VSS	AN28	Power/Other	
VSS	B1	Power/Other	
VSS	B11	Power/Other	
VSS	B14	Power/Other	
VSS	B17	Power/Other	
VSS	B20	Power/Other	



Table 23. Alphabetical Land Assignments

Signal Buffer Land **Land Name** Direction Type B24 Power/Other VSS VSS В5 Power/Other VSS B8 Power/Other VSS C10 Power/Other VSS C13 Power/Other VSS C16 Power/Other Power/Other VSS C19 Power/Other VSS C22 VSS C24 Power/Other VSS C4 Power/Other Power/Other VSS C7 D12 VSS Power/Other VSS D15 Power/Other VSS D18 Power/Other VSS D21 Power/Other VSS D24 Power/Other VSS D3 Power/Other VSS D5 Power/Other D6 Power/Other VSS VSS D9 Power/Other VSS E11 Power/Other VSS E14 Power/Other VSS E17 Power/Other VSS E2 Power/Other VSS E20 Power/Other VSS E25 Power/Other VSS E26 Power/Other VSS E27 Power/Other VSS E28 Power/Other VSS E8 Power/Other VSS F10 Power/Other F13 VSS Power/Other VSS F16 Power/Other F19 Power/Other VSS F22 VSS Power/Other VSS F4 Power/Other VSS F7 Power/Other VSS H10 Power/Other VSS H11 Power/Other

Table 23. Alphabetical Land Assignments

Land Name	Land #	Signal Buffer Type	Direction
VSS	H12	Power/Other	
VSS	H13	Power/Other	
VSS	H14	Power/Other	
VSS	H17	Power/Other	
VSS	H18	Power/Other	
VSS	H19	Power/Other	
VSS	H20	Power/Other	
VSS	H21	Power/Other	
VSS	H22	Power/Other	
VSS	H23	Power/Other	
VSS	H24	Power/Other	
VSS	H25	Power/Other	
VSS	H26	Power/Other	
VSS	H27	Power/Other	
VSS	H28	Power/Other	
VSS	НЗ	Power/Other	
VSS	H6	Power/Other	
VSS	H7	Power/Other	
VSS	H8	Power/Other	
VSS	Н9	Power/Other	
VSS	J4	Power/Other	
VSS	J7	Power/Other	
VSS	K2	Power/Other	
VSS	K5	Power/Other	
VSS	K7	Power/Other	
VSS	L23	Power/Other	
VSS	L24	Power/Other	
VSS	L25	Power/Other	
VSS	L26	Power/Other	
VSS	L27	Power/Other	
VSS	L28	Power/Other	
VSS	L29	Power/Other	
VSS	L3	Power/Other	
VSS	L30	Power/Other	
VSS	L6	Power/Other	
VSS	L7	Power/Other	
VSS	M1	Power/Other	
VSS	M7	Power/Other	
VSS	N3	Power/Other	



Table 23. Alphabetical Land Assignments

Land Signal Buffer **Land Name** Direction Туре VSS N6 Power/Other VSS N7 Power/Other VSS P23 Power/Other VSS P24 Power/Other VSS P25 Power/Other VSS P26 Power/Other VSS P27 Power/Other VSS P28 Power/Other P29 Power/Other VSS P30 VSS Power/Other VSS P4 Power/Other VSS Р7 Power/Other VSS R2 Power/Other VSS R23 Power/Other VSS R24 Power/Other VSS R25 Power/Other VSS R26 Power/Other VSS R27 Power/Other VSS R28 Power/Other VSS R29 Power/Other VSS R30 Power/Other VSS R5 Power/Other VSS R7 Power/Other VSS Т3 Power/Other VSS Т6 Power/Other VSS T7 Power/Other VSS U7 Power/Other VSS V23 Power/Other VSS V24 Power/Other VSS V25 Power/Other VSS V26 Power/Other VSS V27 Power/Other VSS V28 Power/Other VSS V29 Power/Other VSS V3 Power/Other VSS V30 Power/Other VSS ۷6 Power/Other VSS V7 Power/Other VSS W4 Power/Other

Table 23. Alphabetical Land Assignments

Land Name	Land #	Signal Buffer Type	Direction
VSS	W7	Power/Other	
VSS	Y2	Power/Other	
VSS	Y5	Power/Other	
VSS	Y7	Power/Other	
VSS_MB_ REGULATION	AN6	Power/Other	Output
VSS_SENSE	AN4	Power/Other	Output
VSSA	B23	Power/Other	
VTT	A25	Power/Other	
VTT	A26	Power/Other	
VTT	A27	Power/Other	
VTT	A28	Power/Other	
VTT	A29	Power/Other	
VTT	A30	Power/Other	
VTT	B25	Power/Other	
VTT	B26	Power/Other	
VTT	B27	Power/Other	
VTT	B28	Power/Other	
VTT	B29	Power/Other	
VTT	B30	Power/Other	
VTT	C25	Power/Other	
VTT	C26	Power/Other	
VTT	C27	Power/Other	
VTT	C28	Power/Other	
VTT	C29	Power/Other	
VTT	C30	Power/Other	
VTT	D25	Power/Other	
VTT	D26	Power/Other	
VTT	D27	Power/Other	
VTT	D28	Power/Other	
VTT	D29	Power/Other	
VTT	D30	Power/Other	
VTT_OUT_LEFT	J1	Power/Other	Output
VTT_OUT_RIG HT	AA1	Power/Other	Output
VTT_SEL	F27	Power/Other	Output



Table 24. Numerical Land Assignment

Signal Buffer Land **Land Name Direction Type** Α2 VSS Power/Other RS2# Common Clock АЗ Input A4 D02# Source Synch Input/Output Α5 D04# Input/Output Source Synch Α6 VSS Power/Other Α7 D07# Input/Output Source Synch **A8** DBI0# Source Synch Input/Output Α9 VSS Power/Other D08# A10 Source Synch Input/Output A11 D09# Source Synch Input/Output A12 VSS Power/Other COMPO Power/Other A13 Input A14 D50# Source Synch Input/Output A15 VSS Power/Other A16 DSTBN3# Source Synch Input/Output A17 D56# Source Synch Input/Output A18 VSS Power/Other A19 D61# Source Synch Input/Output **RESERVED** A20 A21 VSS Power/Other A22 D62# Source Synch Input/Output VCCA A23 Power/Other A24 FC23 Power/Other A25 VTT Power/Other A26 VTT Power/Other A27 VTT Power/Other A28 VTT Power/Other VTT Power/Other A29 A30 VTT Power/Other В1 VSS Power/Other B2 DBSY# Common Clock Input/Output ВЗ RS0# Common Clock Input B4 D00# Source Synch Input/Output B5 VSS Power/Other В6 D05# Source Synch Input/Output B7 D06# Source Synch Input/Output В8 VSS Power/Other В9 DSTBP0# Source Synch Input/Output D10# B10 Source Synch Input/Output

Table 24. Numerical Land Assignment

Assignment			
Land #	Land Name	Signal Buffer Type	Direction
B11	VSS	Power/Other	
B12	D13#	Source Synch	Input/Output
B13	COMP8	Power/Other	Input
B14	VSS	Power/Other	
B15	D53#	Source Synch	Input/Output
B16	D55#	Source Synch	Input/Output
B17	VSS	Power/Other	
B18	D57#	Source Synch	Input/Output
B19	D60#	Source Synch	Input/Output
B20	VSS	Power/Other	
B21	D59#	Source Synch	Input/Output
B22	D63#	Source Synch	Input/Output
B23	VSSA	Power/Other	
B24	VSS	Power/Other	
B25	VTT	Power/Other	
B26	VTT	Power/Other	
B27	VTT	Power/Other	
B28	VTT	Power/Other	
B29	VTT	Power/Other	
B30	VTT	Power/Other	
C1	DRDY#	Common Clock	Input/Output
C2	BNR#	Common Clock	Input/Output
С3	LOCK#	Common Clock	Input/Output
C4	VSS	Power/Other	
C5	D01#	Source Synch	Input/Output
C6	D03#	Source Synch	Input/Output
C7	VSS	Power/Other	
C8	DSTBN0#	Source Synch	Input/Output
С9	FC38	Power/Other	
C10	VSS	Power/Other	
C11	D11#	Source Synch	Input/Output
C12	D14#	Source Synch	Input/Output
C13	VSS	Power/Other	
C14	D52#	Source Synch	Input/Output
C15	D51#	Source Synch	Input/Output
C16	VSS	Power/Other	
C17	DSTBP3#	Source Synch	Input/Output
C18	D54#	Source Synch	Input/Output
C19	VSS	Power/Other	



Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name Direction Type** C20 DBI3# Source Synch Input/Output D58# C21 Input/Output Source Synch VSS C22 Power/Other C23 VCCIOPLL Power/Other C24 VSS Power/Other C25 VTT Power/Other C26 VTT Power/Other C27 VTT Power/Other VTT C28 Power/Other C29 VTT Power/Other C30 VTT Power/Other D1 RESERVED D2 ADS# Common Clock Input/Output D3 VSS Power/Other HIT# D4 Common Clock Input/Output D5 VSS Power/Other D6 VSS Power/Other D7 D20# Source Synch Input/Output Input/Output D8 D12# Source Synch D9 VSS Power/Other D10 D22# Source Synch Input/Output D15# D11 Input/Output Source Synch D12 VSS Power/Other D13 D25# Source Synch Input/Output RESERVED D14 D15 VSS Power/Other D16 RESERVED D17 D49# Source Synch Input/Output D18 VSS Power/Other D19 DBI2# Source Synch Input/Output D20 D48# Source Synch Input/Output D21 VSS Power/Other D22 D46# Source Synch Input/Output D23 VCCPLL Power/Other D24 VSS Power/Other D25 VTT Power/Other D26 VTT Power/Other D27 VTT Power/Other VTT D28 Power/Other

Table 24. Numerical Land Assignment

Assignment			
Land #	Land Name	Signal Buffer Type	Direction
D29	VTT	Power/Other	
D30	VTT	Power/Other	
E2	VSS	Power/Other	
E3	TRDY#	Common Clock	Input
E4	HITM#	Common Clock	Input/Output
E5	FC20	Power/Other	
E6	RESERVED		
E7	RESERVED		
E8	VSS	Power/Other	
E9	D19#	Source Synch	Input/Output
E10	D21#	Source Synch	Input/Output
E11	VSS	Power/Other	
E12	DSTBP1#	Source Synch	Input/Output
E13	D26#	Source Synch	Input/Output
E14	VSS	Power/Other	
E15	D33#	Source Synch	Input/Output
E16	D34#	Source Synch	Input/Output
E17	VSS	Power/Other	
E18	D39#	Source Synch	Input/Output
E19	D40#	Source Synch	Input/Output
E20	VSS	Power/Other	
E21	D42#	Source Synch	Input/Output
E22	D45#	Source Synch	Input/Output
E23	RESERVED		
E24	FC10	Power/Other	
E25	VSS	Power/Other	
E26	VSS	Power/Other	
E27	VSS	Power/Other	
E28	VSS	Power/Other	
E29	FC26	Power/Other	
F2	FC5	Power/Other	
F3	BRO#	Common Clock	Input/Output
F4	VSS	Power/Other	
F5	RS1#	Common Clock	Input
F6	FC21	Power/Other	
F7	VSS	Power/Other	
F8	D17#	Source Synch	Input/Output
F9	D18#	Source Synch	Input/Output
F10	VSS	Power/Other	



Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name Direction Type** F11 D23# Source Synch Input/Output F12 D24# Source Synch Input/Output F13 VSS Power/Other D28# F14 Source Synch Input/Output F15 D30# Source Synch Input/Output F16 VSS Power/Other F17 D37# Source Synch Input/Output F18 D38# Source Synch Input/Output VSS F19 Power/Other F20 D41# Source Synch Input/Output F21 D43# Source Synch Input/Output VSS F22 Power/Other F23 **RESERVED** F24 TESTH17 Power/Other Input F25 TESTH12 Power/Other Input F26 TESTHI0 Power/Other Input F27 VTT_SEL Power/Other Output F28 **BCLKO** Clock Input F29 **RESERVED** G1 FC27 Power/Other G2 COMP2 Power/Other Input TESTHI8/FC42 G3 Power/Other Input G4 TESTHI9/FC43 Power/Other Input PECI Input/Output G5 Power/Other RESERVED G6 G7 DEFER# Common Clock Input G8 BPRI# Common Clock Input D16# G9 Source Synch Input/Output G10 FC38 Power/Other G11 DBI1# Source Synch Input/Output G12 DSTBN1# Input/Output Source Synch G13 D27# Input/Output Source Synch G14 D29# Source Synch Input/Output G15 D31# Input/Output Source Synch G16 D32# Source Synch Input/Output G17 D36# Source Synch Input/Output G18 D35# Input/Output Source Synch

G19

G20

DSTBP2#

DSTBN2#

Source Synch

Source Synch

Table 24. Numerical Land Assignment

Land #	Land Name	Signal Buffer Type	Direction
G21	D44#	Source Synch	Input/Output
G22	D47#	Source Synch	Input/Output
G23	RESET#	Common Clock	Input
G24	TESTHI6	Power/Other	Input
G25	TESTHI3	Power/Other	Input
G26	TESTHI5	Power/Other	Input
G27	TESTHI4	Power/Other	Input
G28	BCLK1	Clock	Input
G29	BSEL0	Power/Other	Output
G30	BSEL2	Power/Other	Output
H1	GTLREF0	Power/Other	Input
H2	GTLREF1	Power/Other	Input
Н3	VSS	Power/Other	
H4	FC35	Power/Other	
Н5	TESTHI10	Power/Other	Input
Н6	VSS	Power/Other	
H7	VSS	Power/Other	
Н8	VSS	Power/Other	
Н9	VSS	Power/Other	
H10	VSS	Power/Other	
H11	VSS	Power/Other	
H12	VSS	Power/Other	
H13	VSS	Power/Other	
H14	VSS	Power/Other	
H15	FC32	Power/Other	
H16	FC33	Power/Other	
H17	VSS	Power/Other	
H18	VSS	Power/Other	
H19	VSS	Power/Other	
H20	VSS	Power/Other	
H21	VSS	Power/Other	
H22	VSS	Power/Other	
H23	VSS	Power/Other	
H24	VSS	Power/Other	
H25	VSS	Power/Other	
H26	VSS	Power/Other	
H27	VSS	Power/Other	
H28	VSS	Power/Other	
H29	FC15	Power/Other	

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Input/Output

Input/Output

К8



Table 24. **Numerical Land Assignment**

Land Signal Buffer **Land Name Direction Type** H30 BSEL1 Power/Other Output VTT_OUT_LEFT J1 Power/Other Output J2 FC3 Power/Other J3 FC22 Power/Other J4 VSS Power/Other J5 REQ1# Source Synch Input/Output J6 REQ4# Source Synch Input/Output J7 VSS Power/Other J8 VCC Power/Other J9 VCC Power/Other J10 VCC Power/Other J11 VCC Power/Other VCC J12 Power/Other J13 VCC Power/Other VCC Power/Other J14 VCC J15 Power/Other FC31 J16 Power/Other J17 FC34 Power/Other VCC J18 Power/Other J19 VCC Power/Other J20 VCC Power/Other VCC J21 Power/Other J22 VCC Power/Other J23 VCC Power/Other VCC J24 Power/Other J25 VCC Power/Other J26 VCC Power/Other J27 VCC Power/Other J28 VCC Power/Other J29 VCC Power/Other J30 VCC Power/Other LINTO Κ1 Asynch CMOS Input VSS K2 Power/Other К3 A20M# Asynch CMOS Input REQ0# K4 Source Synch Input/Output VSS Κ5 Power/Other Κ6 REQ3# Source Synch Input/Output Κ7 VSS Power/Other VCC

Table 24. **Numerical Land Assignment**

Assignment			
Land #	Land Name	Signal Buffer Type	Direction
K23	VCC	Power/Other	
K24	VCC	Power/Other	
K25	VCC	Power/Other	
K26	VCC	Power/Other	
K27	VCC	Power/Other	
K28	VCC	Power/Other	
K29	VCC	Power/Other	
K30	VCC	Power/Other	
L1	LINT1	Asynch CMOS	Input
L2	TESTHI13	Power/Other	Input
L3	VSS	Power/Other	
L4	A06#	Source Synch	Input/Output
L5	A03#	Source Synch	Input/Output
L6	VSS	Power/Other	
L7	VSS	Power/Other	
L8	VCC	Power/Other	
L23	VSS	Power/Other	
L24	VSS	Power/Other	
L25	VSS	Power/Other	
L26	VSS	Power/Other	
L27	VSS	Power/Other	
L28	VSS	Power/Other	
L29	VSS	Power/Other	
L30	VSS	Power/Other	
M1	VSS	Power/Other	
M2	THERMTRIP#	Asynch CMOS	Output
М3	STPCLK#	Asynch CMOS	Input
M4	A07#	Source Synch	Input/Output
M5	A05#	Source Synch	Input/Output
M6	REQ2#	Source Synch	Input/Output
M7	VSS	Power/Other	
M8	VCC	Power/Other	
M23	VCC	Power/Other	
M24	VCC	Power/Other	
M25	VCC	Power/Other	
M26	VCC	Power/Other	
M27	VCC	Power/Other	
M28	VCC	Power/Other	
M29	VCC	Power/Other	

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Power/Other



Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name** Direction Type M30 VCC Power/Other **PWRGOOD** Power/Other N1 Input N2 IGNNE# Asynch CMOS Input N3 VSS Power/Other N4 **RESERVED** N5 RESERVED Power/Other N6 VSS Power/Other N7 VSS Ν8 VCC Power/Other N23 VCC Power/Other Power/Other N24 VCC VCC N25 Power/Other N26 VCC Power/Other N27 VCC Power/Other VCC Power/Other N28 N29 VCC Power/Other N30 VCC Power/Other Р1 TESTHI11 Power/Other Input P2 SMI# Asynch CMOS Input Р3 INIT# Asynch CMOS Input P4 VSS Power/Other P5 RESERVED Р6 A04# Source Synch Input/Output P7 VSS Power/Other P8 VCC Power/Other P23 VSS Power/Other P24 VSS Power/Other P25 VSS Power/Other P26 VSS Power/Other P27 VSS Power/Other P28 VSS Power/Other P29 VSS Power/Other P30 VSS Power/Other COMP3 Power/Other R1 Input VSS R2 Power/Other FERR#/PBE# R3 Asynch CMOS Output R4 A08# Source Synch Input/Output R5 VSS Power/Other ADSTB0# R6 Source Synch Input/Output

Table 24. Numerical Land Assignment

	<u> </u>		
Land #	Land Name	Signal Buffer Type	Direction
R7	VSS	Power/Other	
R8	VCC	Power/Other	
R23	VSS	Power/Other	
R24	VSS	Power/Other	
R25	VSS	Power/Other	
R26	VSS	Power/Other	
R27	VSS	Power/Other	
R28	VSS	Power/Other	
R29	VSS	Power/Other	
R30	VSS	Power/Other	
T1	COMP1	Power/Other	Input
T2	FC4	Power/Other	
Т3	VSS	Power/Other	
T4	A11#	Source Synch	Input/Output
T5	A09#	Source Synch	Input/Output
T6	VSS	Power/Other	
T7	VSS	Power/Other	
T8	VCC	Power/Other	
T23	VCC	Power/Other	
T24	VCC	Power/Other	
T25	VCC	Power/Other	
T26	VCC	Power/Other	
T27	VCC	Power/Other	
T28	VCC	Power/Other	
T29	VCC	Power/Other	
T30	VCC	Power/Other	
U1	FC28	Power/Other	
U2	FC29	Power/Other	
U3	FC30	Power/Other	
U4	A13#	Source Synch	Input/Output
U5	A12#	Source Synch	Input/Output
U6	A10#	Source Synch	Input/Output
U7	VSS	Power/Other	
U8	VCC	Power/Other	
U23	VCC	Power/Other	
U24	VCC	Power/Other	
U25	VCC	Power/Other	
U26	VCC	Power/Other	
U27	VCC	Power/Other	

Y4

A20#



Table 24. **Numerical Land Assignment**

Land Signal Buffer **Land Name Direction** Type U28 VCC Power/Other U29 VCC Power/Other VCC U30 Power/Other V1 MSID1 Power/Other Output V2 RESERVED VSS V3 Power/Other V4 A15# Source Synch Input/Output ۷5 A14# Input/Output Source Synch VSS V6 Power/Other ٧7 VSS Power/Other ۷8 VCC Power/Other V23 VSS Power/Other VSS V24 Power/Other V25 VSS Power/Other VSS Power/Other V26 V27 VSS Power/Other V28 VSS Power/Other V29 VSS Power/Other V30 VSS Power/Other W1 MSID0 Power/Other Output TESTHI12/FC44 W2 Power/Other Input TESTHI1 W3 Power/Other Input W4 VSS Power/Other W5 A16# Source Synch Input/Output W6 A18# Input/Output Source Synch W7 VSS Power/Other W8 VCC Power/Other W23 VCC Power/Other W24 VCC Power/Other W25 VCC Power/Other W26 VCC Power/Other W27 VCC Power/Other W28 VCC Power/Other W29 VCC Power/Other W30 VCC Power/Other FC0 Υ1 Power/Other Y2 VSS Power/Other Υ3 FC17 Power/Other

Table 24. **Numerical Land Assignment**

Assignment			
Land #	Land Name	Signal Buffer Type	Direction
Y5	VSS	Power/Other	
Y6	A19#	Source Synch	Input/Output
Y7	VSS	Power/Other	
Y8	VCC	Power/Other	
Y23	VCC	Power/Other	
Y24	VCC	Power/Other	
Y25	VCC	Power/Other	
Y26	VCC	Power/Other	
Y27	VCC	Power/Other	
Y28	VCC	Power/Other	
Y29	VCC	Power/Other	
Y30	VCC	Power/Other	
AA1	VTT_OUT_RIGHT	Power/Other	Output
AA2	FC39	Power/Other	
AA3	VSS	Power/Other	
AA4	A21#	Source Synch	Input/Output
AA5	A23#	Source Synch	Input/Output
AA6	VSS	Power/Other	
AA7	VSS	Power/Other	
AA8	VCC	Power/Other	
AA23	VSS	Power/Other	
AA24	VSS	Power/Other	
AA25	VSS	Power/Other	
AA26	VSS	Power/Other	
AA27	VSS	Power/Other	
AA28	VSS	Power/Other	
AA29	VSS	Power/Other	
AA30	VSS	Power/Other	
AB1	VSS	Power/Other	
AB2	IERR#	Asynch CMOS	Output
AB3	FC37	Power/Other	
AB4	A26#	Source Synch	Input/Output
AB5	A24#	Source Synch	Input/Output
AB6	A17#	Source Synch	Input/Output
AB7	VSS	Power/Other	
AB8	VCC	Power/Other	
AB23	VSS	Power/Other	
AB24	VSS	Power/Other	
AB25	VSS	Power/Other	

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Source Synch Input/Output



Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name** Direction Type Power/Other AB26 VSS VSS Power/Other AB27 AB28 Power/Other VSS AB29 VSS Power/Other **AB30** VSS Power/Other AC1 TMS TAP Input Power/Other AC2 DBR# Output AC3 VSS Power/Other AC4 RESERVED AC5 A25# Source Synch Input/Output AC6 VSS Power/Other VSS AC7 Power/Other AC8 VCC Power/Other AC23 VCC Power/Other AC24 VCC Power/Other AC25 VCC Power/Other AC26 VCC Power/Other AC27 VCC Power/Other AC28 VCC Power/Other AC29 VCC Power/Other AC30 VCC Power/Other AD1 TDI TAP Input AD2 BPM2# Common Clock Input/Output AD3 FC36 Power/Other AD4 VSS Power/Other AD5 ADSTB1# Source Synch Input/Output AD6 A22# Source Synch Input/Output AD7 VSS Power/Other AD8 VCC Power/Other AD23 VCC Power/Other AD24 VCC Power/Other AD25 VCC Power/Other AD26 VCC Power/Other AD27 VCC Power/Other AD28 VCC Power/Other AD29 VCC Power/Other AD30 VCC Power/Other AE1 TCK TAP Input VSS AE2 Power/Other

Table 24. Numerical Land Assignment

Assignment			
Land #	Land Name	Signal Buffer Type	Direction
AE3	FC18	Power/Other	
AE4	RESERVED		
AE5	VSS	Power/Other	
AE6	RESERVED		
AE7	VSS	Power/Other	
AE8	SKTOCC#	Power/Other	Output
AE9	VCC	Power/Other	
AE10	VSS	Power/Other	
AE11	VCC	Power/Other	
AE12	VCC	Power/Other	
AE13	VSS	Power/Other	
AE14	VCC	Power/Other	
AE15	VCC	Power/Other	
AE16	VSS	Power/Other	
AE17	VSS	Power/Other	
AE18	VCC	Power/Other	
AE19	VCC	Power/Other	
AE20	VSS	Power/Other	
AE21	VCC	Power/Other	
AE22	VCC	Power/Other	
AE23	VCC	Power/Other	
AE24	VSS	Power/Other	
AE25	VSS	Power/Other	
AE26	VSS	Power/Other	
AE27	VSS	Power/Other	
AE28	VSS	Power/Other	
AE29	VSS	Power/Other	
AE30	VSS	Power/Other	
AF1	TDO	TAP	Output
AF2	BPM4#	Common Clock	Input/Output
AF3	VSS	Power/Other	
AF4	A28#	Source Synch	Input/Output
AF5	A27#	Source Synch	Input/Output
AF6	VSS	Power/Other	
AF7	VSS	Power/Other	
AF8	VCC	Power/Other	
AF9	VCC	Power/Other	
AF10	VSS	Power/Other	
AF11	VCC	Power/Other	

AG19

AG20

VCC

VSS

Power/Other

Power/Other



Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name Direction** Type AF12 VCC Power/Other AF13 VSS Power/Other VCC Power/Other AF14 AF15 VCC Power/Other AF16 VSS Power/Other VSS AF17 Power/Other AF18 VCC Power/Other AF19 VCC Power/Other AF20 VSS Power/Other AF21 VCC Power/Other AF22 VCC Power/Other AF23 VSS Power/Other AF24 VSS Power/Other AF25 VSS Power/Other AF26 VSS Power/Other AF27 VSS Power/Other AF28 VSS Power/Other AF29 VSS Power/Other AF30 VSS Power/Other AG1 TRST# TAP Input AG2 BPM3# Common Clock Input/Output AG3 BPM5# Common Clock Input/Output AG4 A30# Source Synch Input/Output AG5 A31# Source Synch Input/Output AG6 A29# Input/Output Source Synch AG7 VSS Power/Other AG8 VCC Power/Other AG9 VCC Power/Other AG10 VSS Power/Other AG11 VCC Power/Other AG12 VCC Power/Other AG13 VSS Power/Other AG14 VCC Power/Other AG15 VCC Power/Other AG16 VSS Power/Other VSS AG17 Power/Other AG18 VCC Power/Other

Table 24. Numerical Land Assignment

Land #	Land Name	Signal Buffer Type	Direction
AG21	VCC	Power/Other	
AG22	VCC	Power/Other	
AG23	VSS	Power/Other	
AG24	VSS	Power/Other	
AG25	VCC	Power/Other	
AG26	VCC	Power/Other	
AG27	VCC	Power/Other	
AG28	VCC	Power/Other	
AG29	VCC	Power/Other	
AG30	VCC	Power/Other	
AH1	VSS	Power/Other	
AH2	RESERVED		
АН3	VSS	Power/Other	
AH4	A32#	Source Synch	Input/Output
AH5	A33#	Source Synch	Input/Output
AH6	VSS	Power/Other	
AH7	VSS	Power/Other	
AH8	VCC	Power/Other	
AH9	VCC	Power/Other	
AH10	VSS	Power/Other	
AH11	VCC	Power/Other	
AH12	VCC	Power/Other	
AH13	VSS	Power/Other	
AH14	VCC	Power/Other	
AH15	VCC	Power/Other	
AH16	VSS	Power/Other	
AH17	VSS	Power/Other	
AH18	VCC	Power/Other	
AH19	VCC	Power/Other	
AH20	VSS	Power/Other	
AH21	VCC	Power/Other	
AH22	VCC	Power/Other	
AH23	VSS	Power/Other	
AH24	VSS	Power/Other	
AH25	VCC	Power/Other	
AH26	VCC	Power/Other	
AH27	VCC	Power/Other	
AH28	VCC	Power/Other	
AH29	VCC	Power/Other	



Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name** Direction Type VCC Power/Other AH30 BPM1# Common Clock Input/Output AJ1 AJ2 BPM0# Common Clock Input/Output AJ3 ITP_CLK1 TAP Input Power/Other AJ4 VSS AJ5 A34# Source Synch Input/Output AJ6 A35# Source Synch Input/Output Power/Other AJ7 VSS AJ8 VCC Power/Other AJ9 VCC Power/Other AJ10 Power/Other VSS VCC AJ11 Power/Other AJ12 VCC Power/Other AJ13 VSS Power/Other AJ14 VCC Power/Other AJ15 VCC Power/Other AJ16 VSS Power/Other AJ17 VSS Power/Other AJ18 VCC Power/Other AJ19 VCC Power/Other AJ20 VSS Power/Other AJ21 VCC Power/Other AJ22 VCC Power/Other AJ23 VSS Power/Other AJ24 VSS Power/Other AJ25 VCC Power/Other AJ26 VCC Power/Other AJ27 VSS Power/Other AJ28 VSS Power/Other AJ29 VSS Power/Other AJ30 VSS Power/Other THERMDC AK1 Power/Other AK2 VSS Power/Other ITP_CLK0 TAP AK3 Input AK4 VID4 Power/Other Output AK5 VSS Power/Other AK6 FC8 Power/Other Power/Other AK7 VSS VCC AK8 Power/Other

Table 24. Numerical Land Assignment

		1	1
Land #	Land Name	Signal Buffer Type	Direction
AK9	VCC	Power/Other	
AK10	VSS	Power/Other	
AK11	VCC	Power/Other	
AK12	VCC	Power/Other	
AK13	VSS	Power/Other	
AK14	VCC	Power/Other	
AK15	VCC	Power/Other	
AK16	VSS	Power/Other	
AK17	VSS	Power/Other	
AK18	VCC	Power/Other	
AK19	VCC	Power/Other	
AK20	VSS	Power/Other	
AK21	VCC	Power/Other	
AK22	VCC	Power/Other	
AK23	VSS	Power/Other	
AK24	VSS	Power/Other	
AK25	VCC	Power/Other	
AK26	VCC	Power/Other	
AK27	VSS	Power/Other	
AK28	VSS	Power/Other	
AK29	VSS	Power/Other	
AK30	VSS	Power/Other	
AL1	THERMDA	Power/Other	
AL2	PROCHOT#	Asynch CMOS	Input/Output
AL3	VRDSEL	Power/Other	
AL4	VID5	Power/Other	Output
AL5	VID1	Power/Other	Output
AL6	VID3	Power/Other	Output
AL7	VSS	Power/Other	
AL8	VCC	Power/Other	
AL9	VCC	Power/Other	
AL10	VSS	Power/Other	
AL11	VCC	Power/Other	
AL12	VCC	Power/Other	
AL13	VSS	Power/Other	
AL14	VCC	Power/Other	
AL15	VCC	Power/Other	
AL16	VSS	Power/Other	
AL17	VSS	Power/Other	

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Table 24. Numerical Land Assignment

Land Signal Buffer **Land Name** Direction Type AL18 VCC Power/Other AL19 VCC Power/Other VSS AL20 Power/Other AL21 VCC Power/Other AL22 VCC Power/Other AL23 VSS Power/Other AL24 VSS Power/Other AL25 VCC Power/Other AL26 VCC Power/Other AL27 VSS Power/Other AL28 VSS Power/Other AL29 VCC Power/Other AL30 VCC Power/Other AM1 VSS Power/Other VIDO Power/Other AM2 Output VID2 АМ3 Power/Other Output VSS AM4 Power/Other AM5 VID6 Power/Other Output AM6 FC40 Power/Other VID7 AM7 Power/Other Output 8MA VCC Power/Other AM9 VCC Power/Other AM10 VSS Power/Other AM11 VCC Power/Other VCC AM12 Power/Other AM13 VSS Power/Other AM14 VCC Power/Other AM15 VCC Power/Other AM16 VSS Power/Other AM17 VSS Power/Other AM18 VCC Power/Other AM19 VCC Power/Other AM20 VSS Power/Other AM21 VCC Power/Other AM22 VCC Power/Other VSS AM23 Power/Other AM24 VSS Power/Other AM25 VCC Power/Other VCC AM26 Power/Other

Table 24. Numerical Land Assignment

	,	-	1
Land #	Land Name	Signal Buffer Type	Direction
AM27	VSS	Power/Other	
AM28	VSS	Power/Other	
AM29	VCC	Power/Other	
AM30	VCC	Power/Other	
AN1	VSS	Power/Other	
AN2	VSS	Power/Other	
AN3	VCC_SENSE	Power/Other	Output
AN4	VSS_SENSE	Power/Other	Output
AN5	VCC_MB_ REGULATION	Power/Other	Output
AN6	VSS_MB_ REGULATION	Power/Other	Output
AN7	VID_SELECT	Power/Other	Output
AN8	VCC	Power/Other	
AN9	VCC	Power/Other	
AN10	VSS	Power/Other	
AN11	VCC	Power/Other	
AN12	VCC	Power/Other	
AN13	VSS	Power/Other	
AN14	VCC	Power/Other	
AN15	VCC	Power/Other	
AN16	VSS	Power/Other	
AN17	VSS	Power/Other	
AN18	VCC	Power/Other	
AN19	VCC	Power/Other	
AN20	VSS	Power/Other	
AN21	VCC	Power/Other	
AN22	VCC	Power/Other	
AN23	VSS	Power/Other	
AN24	VSS	Power/Other	
AN25	VCC	Power/Other	
AN26	VCC	Power/Other	
AN27	VSS	Power/Other	
AN28	VSS	Power/Other	
AN29	VCC	Power/Other	
AN30	VCC	Power/Other	



4.2 Alphabetical Signals Reference

Table 25. Signal Description (Sheet 1 of 9)

Name	Туре	Description	
A[35:3]#	Input/ Output	A[35:3]# (Address) define a 2 ³⁶ -byte physical memory address space. In sub-phase 1 of the address phase, these signals transmit the address of a transaction. In sub-phase 2, these signals transmit transaction type information. These signals must connect the appropriate pins/lands of all agents on the processor FSB. A[35:3]# are source synchronous signals and are latched into the receiving buffers by ADSTB[1:0]#. On the active-to-inactive transition of RESET#, the processor samples a subset of the A[35:3]# signals to determine power-on configuration. See Section 6.1 for more details.	
A20M#	Input	If A20M# (Address-20 Mask) is asserted, the processor masks physical address bit 20 (A20#) before looking up a line in any internal cache and before driving a read/write transaction on the bus. Asserting A20M# emulates the 8086 processor's address wraparound at the 1-MB boundary. Assertion of A20M# is only supported in real mode. A20M# is an asynchronous signal. However, to ensure recognition of this signal following an Input/Output write instruction, it must be valid along with the TRDY# assertion of the corresponding Input/Output Write bus transaction.	
ADS#	Input/ Output	ADS# (Address Strobe) is asserted to indicate the validity of the transaction address on the A[35:3]# and REQ[4:0]# signals. All bus agents observe the ADS# activation to begin protocol checking, address decode, internal snoop, or deferred reply ID match operations associated with the new transaction.	
ADSTB[1:0]#	Input/ Output	Address strobes are used to latch A[35:3]# and REQ[4:0]# on their rising and falling edges. Strobes are associated with signals as shown below. Signals Associated Strobe REQ[4:0]#, A[16:3]# ADSTB0# A[35:17]# ADSTB1#	
BCLK[1:0]	Input	The differential pair BCLK (Bus Clock) determines the FSB frequency. All processor FSB agents must receive these signals to drive their outputs and latch their inputs. All external timing parameters are specified with respect to the rising edge of BCLKO crossing V _{CROSS} .	
BNR#	Input/ Output	BNR# (Block Next Request) is used to assert a bus stall by any bus agent unable to accept new bus transactions. During a bus stall, the current bus owner cannot issue any new transactions.	

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Table 25. Signal Description (Sheet 2 of 9)

Name	Туре	Description
BPM[5:0]#	Input/ Output	BPM[5:0]# (Breakpoint Monitor) are breakpoint and performance monitor signals. They are outputs from the processor which indicate the status of breakpoints and programmable counters used for monitoring processor performance. BPM[5:0]# should connect the appropriate pins/lands of all processor FSB agents. BPM4# provides PRDY# (Probe Ready) functionality for the TAP port. PRDY# is a processor output used by debug tools to determine processor debug readiness. BPM5# provides PREQ# (Probe Request) functionality for the TAP port. PREQ# is used by debug tools to request debug operation of the processor. These signals do not have on-die termination. Refer to Section 2.6.2 for termination requirements.
BPRI#	Input	BPRI# (Bus Priority Request) is used to arbitrate for ownership of the processor FSB. It must connect the appropriate pins/lands of all processor FSB agents. Observing BPRI# active (as asserted by the priority agent) causes all other agents to stop issuing new requests, unless such requests are part of an ongoing locked operation. The priority agent keeps BPRI# asserted until all of its requests are completed, then releases the bus by de-asserting BPRI#.
BRO#	Input/ Output	BRO# drives the BREQO# signal in the system and is used by the processor to request the bus. During power-on configuration this signal is sampled to determine the agent ID = 0. This signal does not have on-die termination and must be terminated.
BSEL[2:0]	Output	The BCLK[1:0] frequency select signals BSEL[2:0] are used to select the processor input clock frequency. Table 16 defines the possible combinations of the signals and the frequency associated with each combination. The required frequency is determined by the processor, chipset and clock synthesizer. All agents must operate at the same frequency. For more information about these signals, including termination recommendations refer to Section 2.8.2.
COMP8 COMP[3:0]	Analog	COMP[3:0] and COMP8 must be terminated to V_{SS} on the system board using precision resistors.



Table 25. Signal Description (Sheet 3 of 9)

Name	Туре	Description		
		D[63:0]# (Data) are the data signals. These signals provide a 64-bit data path between the processor FSB agents, and must connect the appropriate pins/lands on all such agents. The data driver asserts DRDY# to indicate a valid data transfer.		
		times in a common clock peri edge of both DSTBP[3:0]# and data signals correspond to a	signals and will, thus, be driven four iod. D[63:0]# are latched off the falling and DSTBN[3:0]#. Each group of 16 pair of one DSTBP# and one DSTBN#. e grouping of data signals to data	
	Input/	Quad-Pumped Signal Groups	;	
D[63:0]#	Input/ Output	Data Group DSTBN DSTBR	DBI#	
		D[15:0]# 0	0	
		D[31:16]# 1	1	
		D[47:32]# 2	2	
		D[63:48]# 3	3	
		signals. Each group of 16 dat signal. When the DBI# signal group is inverted and therefo	· •	
	Input/ Output	indicate the polarity of the D are activated when the data of than half the data bits, within asserted electrically low, the	ion) are source synchronous and [63:0]# signals. The DBI[3:0]# signals on the data bus is inverted. If more n a 16-bit group, would have been bus agent may invert the data bus p-phase for that 16-bit group.	
		DBI[3:0] Assignment To Data	a Bus	
DBI[3:0]#		Bus Signal Data	Bus Signals	
		DBI3# D	0[63:48]#	
		DBI2# D	[47:32]#	
		DBI1# D	[31:16]#	
		DBIO#	D[15:0]#	
DBR#	Output	debug port is implemented or debug port interposer so that	only in processor systems where no in the system board. DBR# is used by a t an in-target probe can drive system emented in the system, DBR# is a no # is not a processor signal.	
DBSY#	Input/ Output	driving data on the processor use. The data bus is released	sserted by the agent responsible for r FSB to indicate that the data bus is in after DBSY# is de-asserted. This signal e pins/lands on all processor FSB	

Datasheet Datasheet



Table 25. Signal Description (Sheet 4 of 9)

Name	Туре		Description
DEFER#	Input	DEFER# is asserted by an agent to indicate that a transaction cannot be ensured in-order completion. Assertion of DEFER# is normally the responsibility of the addressed memory or input/output agent. This signal must connect the appropriate pins/lands of all processor FSB agents.	
DRDY#	Input/ Output	DRDY# (Data Ready) is asserted by the data driver on each data transfer, indicating valid data on the data bus. In a multi-common clock data transfer, DRDY# may be de-asserted to insert idle clocks. This signal must connect the appropriate pins/lands of all processor FSB agents.	
		DSTBN[3:0]# are the d	ata strobes used to latch in D[63:0]#.
		Signals	Associated Strobe
	Input/	D[15:0]#, DBI0#	DSTBNO#
DSTBN[3:0]#	Output	D[31:16]#, DBI1#	DSTBN1#
		D[47:32]#, DBI2#	DSTBN2#
		D[63:48]#, DBI3#	DSTBN3#
		DSTBP[3:0]# are the d	ata strobes used to latch in D[63:0]#.
	Input/ Output	Signals	Associated Strobe
		D[15:0]#, DBI0#	DSTBP0#
DSTBP[3:0]#		D[31:16]#, DBI1#	DSTBP1#
		D[47:32]#, DBI2#	DSTBP2#
		D[63:48]#, DBI3#	DSTBP3#
FCx	Other	FC signals are signals that are available for compatibility with other processors.	
FERR#/PBE#	Output	FERR#/PBE# (floating point error/pending break event) is a multiplexed signal and its meaning is qualified by STPCLK#. When STPCLK# is not asserted, FERR#/PBE# indicates a floating-point error and will be asserted when the processor detects an unmasked floating-point error. When STPCLK# is not asserted, FERR#/PBE# is similar to the ERROR# signal on the Intel 387 coprocessor, and is included for compatibility with systems using MS-DOS*-type floating-point error reporting. When STPCLK# is asserted, an assertion of FERR#/PBE# indicates that the processor has a pending break event waiting for service. The assertion of FERR#/PBE# indicates that the processor should be returned to the Normal state. For additional information on the pending break event functionality, including the identification of support of the feature and enable/ disable information, refer to volume 3 of the Intel Architecture Software Developer's Manual and the Intel Processor Identification and the CPUID Instruction application note.	
GTLREF[1:0]	Input	GTLREF[1:0] determine the signal reference level for GTL+ input signals. GTLREF is used by the GTL+ receivers to determine if a signal is a logical 0 or logical 1.	



Table 25. Signal Description (Sheet 5 of 9)

Name	Туре	Description
HIT#	Input/ Output Input/	HIT# (Snoop Hit) and HITM# (Hit Modified) convey transaction snoop operation results. Any FSB agent may assert both HIT# and HITM# together to indicate that it requires a snoop stall, which can be continued by reasserting HIT# and HITM# together.
	Output	IERR# (Internal Error) is asserted by a processor as the result of an
IERR#	Output	internal error. Assertion of IERR# is usually accompanied by a SHUTDOWN transaction on the processor FSB. This transaction may optionally be converted to an external error signal (e.g., NMI) by system core logic. The processor will keep IERR# asserted until the assertion of RESET#.
		This signal does not have on-die termination. Refer to Section 2.6.2 for termination requirements.
IGNNE#	Input	IGNNE# (Ignore Numeric Error) is asserted to the processor to ignore a numeric error and continue to execute noncontrol floating-point instructions. If IGNNE# is de-asserted, the processor generates an exception on a noncontrol floating-point instruction if a previous floating-point instruction caused an error. IGNNE# has no effect when the NE bit in control register 0 (CR0) is set.
		IGNNE# is an asynchronous signal. However, to ensure recognition of this signal following an Input/Output write instruction, it must be valid along with the TRDY# assertion of the corresponding Input/Output Write bus transaction.
INIT#	Input	INIT# (Initialization), when asserted, resets integer registers inside the processor without affecting its internal caches or floating-point registers. The processor then begins execution at the power-on Reset vector configured during power-on configuration. The processor continues to handle snoop requests during INIT# assertion. INIT# is an asynchronous signal and must connect the appropriate pins/lands of all processor FSB agents.
ITP_CLK[1:0]	Input	ITP_CLK[1:0] are copies of BCLK that are used only in processor systems where no debug port is implemented on the system board. ITP_CLK[1:0] are used as BCLK[1:0] references for a debug port implemented on an interposer. If a debug port is implemented in the system, ITP_CLK[1:0] are no connects in the system. These are not processor signals.
LINT[1:0]	Input	LINT[1:0] (Local APIC Interrupt) must connect the appropriate pins/lands of all APIC Bus agents. When the APIC is disabled, the LINTO signal becomes INTR, a maskable interrupt request signal, and LINT1 becomes NMI, a nonmaskable interrupt. INTR and NMI are backward compatible with the signals of those names on the Pentium processor. Both signals are asynchronous. Both of these signals must be software configured via BIOS
		programming of the APIC register space to be used either as NMI/INTR or LINT[1:0]. Because the APIC is enabled by default after Reset, operation of these signals as LINT[1:0] is the default configuration.

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Table 25. Signal Description (Sheet 6 of 9)

Name	Туре	Description
LOCK#	Input/ Output	LOCK# indicates to the system that a transaction must occur atomically. This signal must connect the appropriate pins/lands of all processor FSB agents. For a locked sequence of transactions, LOCK# is asserted from the beginning of the first transaction to the end of the last transaction. When the priority agent asserts BPRI# to arbitrate for ownership of the processor FSB, it will wait until it observes LOCK# de-asserted. This enables symmetric agents to retain ownership of the processor FSB throughout the bus locked operation and ensure the atomicity of lock.
MSID[1:0]	Output	These signals indicate the Market Segment for the processor. Refer to Table 3 for additional information.
PECI	Input/ Output	PECI is a proprietary one-wire bus interface. See Section 5.4 for details.
PROCHOT#	Input/ Output	As an output, PROCHOT# (Processor Hot) will go active when the processor temperature monitoring sensor detects that the processor has reached its maximum safe operating temperature. This indicates that the processor Thermal Control Circuit (TCC) has been activated, if enabled. As an input, assertion of PROCHOT# by the system will activate the TCC, if enabled. The TCC will remain active until the system de-asserts PROCHOT#. See Section 5.2.4 for more details.
PWRGOOD	Input	PWRGOOD (Power Good) is a processor input. The processor requires this signal to be a clean indication that the clocks and power supplies are stable and within their specifications. 'Clean' implies that the signal will remain low (capable of sinking leakage current), without glitches, from the time that the power supplies are turned on until they come within specification. The signal must then transition monotonically to a high state. PWRGOOD can be driven inactive at any time, but clocks and power must again be stable before a subsequent rising edge of PWRGOOD.
		The PWRGOOD signal must be supplied to the processor; it is used to protect internal circuits against voltage sequencing issues. It should be driven high throughout boundary scan operation.
REQ[4:0]#	Input/ Output	REQ[4:0]# (Request Command) must connect the appropriate pins/ lands of all processor FSB agents. They are asserted by the current bus owner to define the currently active transaction type. These signals are source synchronous to ADSTB0#.
RESET#	Input	Asserting the RESET# signal resets the processor to a known state and invalidates its internal caches without writing back any of their contents. For a power-on Reset, RESET# must stay active for at least one millisecond after V_{CC} and BCLK have reached their proper specifications. On observing active RESET#, all FSB agents will deassert their outputs within two clocks. RESET# must not be kept asserted for more than 10 ms while PWRGOOD is asserted. A number of bus signals are sampled at the active-to-inactive transition of RESET# for power-on configuration. These configuration options are described in the Section 6.1. This signal does not have on-die termination and must be terminated on the system based.
RESERVED		terminated on the system board. All RESERVED lands must remain unconnected. Connection of these lands to Vcc, V _{SS} , VTT, or to any other signal (including each other) can result in component malfunction or incompatibility with future processors.



Table 25. Signal Description (Sheet 7 of 9)

Name	Туре	Description
RS[2:0]#	Input	RS[2:0]# (Response Status) are driven by the response agent (the agent responsible for completion of the current transaction), and must connect the appropriate pins/lands of all processor FSB agents.
SKTOCC#	Output	SKTOCC# (Socket Occupied) will be pulled to ground by the processor. System board designers may use this signal to determine if the processor is present.
SMI#	Input	SMI# (System Management Interrupt) is asserted asynchronously by system logic. On accepting a System Management Interrupt, the processor saves the current state and enter System Management Mode (SMM). An SMI Acknowledge transaction is issued, and the processor begins program execution from the SMM handler. If SMI# is asserted during the de-assertion of RESET#, the processor will tri-state its outputs.
STPCLK#	Input	STPCLK# (Stop Clock), when asserted, causes the processor to enter a low power Stop-Grant state. The processor issues a Stop-Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the FSB and APIC units. The processor continues to snoop bus transactions and service interrupts while in Stop-Grant state. When STPCLK# is de-asserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input.
TCK	Input	TCK (Test Clock) provides the clock input for the processor Test Bus (also known as the Test Access Port).
TDI	Input	TDI (Test Data In) transfers serial test data into the processor. TDI provides the serial input needed for JTAG specification support.
TDO	Output	TDO (Test Data Out) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support.
TESTHI[13:0]	Input	TESTHI[13:0] must be connected to the processor's appropriate power source (refer to VTT_OUT_LEFT and VTT_OUT_RIGHT signal description) through a resistor for proper processor operation. See Section 2.5 for more details.
THERMDA	Other	Thermal Diode Anode. See Section 5.3.
THERMDC	Other	Thermal Diode Cathode. See Section 5.3.



Table 25. Signal Description (Sheet 8 of 9)

Name	Туре	Description
THERMTRIP#	Output	In the event of a catastrophic cooling failure, the processor will automatically shut down when the silicon has reached a temperature approximately 20 °C above the maximum T_{C} . Assertion of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond where permanent silicon damage may occur. Upon assertion of THERMTRIP#, the processor will shut off its internal clocks (thus, halting program execution) in an attempt to reduce the processor junction temperature. To protect the processor, its core voltage (V_{CC}) must be removed following the assertion of THERMTRIP#. Driving of the THERMTRIP# signal is enabled within 10 μ s of the assertion of PWRGOOD (provided V_{TT} and V_{CC} are valid) and is disabled on de-assertion of PWRGOOD (if V_{TT} or V_{CC} are not valid, THERMTRIP# may also be disabled). Once activated, THERMTRIP# remains latched until PWRGOOD, V_{TT} , or V_{CC} is de-asserted. While the de-assertion of the PWRGOOD, V_{TT} , or V_{CC} will de-assert THERMTRIP#, if the processor's junction temperature remains at or above the trip level, THERMTRIP# will again be asserted within 10 μ s of the assertion of PWRGOOD (provided V_{TT} and V_{CC} are valid).
TMS	Input	TMS (Test Mode Select) is a JTAG specification support signal used by debug tools.
TRDY#	Input	TRDY# (Target Ready) is asserted by the target to indicate that it is ready to receive a write or implicit writeback data transfer. TRDY# must connect the appropriate pins/lands of all FSB agents.
TRST#	Input	TRST# (Test Reset) resets the Test Access Port (TAP) logic. TRST# must be driven low during power on Reset.
VCC	Input	VCC are the power pins for the processor. The voltage supplied to these pins is determined by the VID[7:0] pins.
VCCPLL	Input	VCCPLL provides isolated power for internal processor FSB PLLs.
VCC_SENSE	Output	VCC_SENSE is an isolated low impedance connection to processor core power (V _{CC}). It can be used to sense or measure voltage near the silicon with little noise.
VCC_MB_ REGULATION	Output	This land is provided as a voltage regulator feedback sense point for V_{CC} . It is connected internally in the processor package to the sense point land U27 as described in the <i>Voltage Regulator-Down (VRD)</i> 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket.
VID[7:0]	Output	VID[7:0] (Voltage ID) signals are used to support automatic selection of power supply voltages ($V_{\rm CC}$). Refer to the <i>Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket</i> for more information. The voltage supply for these signals must be valid before the VR can supply $V_{\rm CC}$ to the processor. Conversely, the VR output must be disabled until the voltage supply for the VID signals becomes valid. The VID signals are needed to support the processor voltage specification variations. See Table 2 for definitions of these signals. The VR must supply the voltage that is requested by the signals, or disable itself.
VID_SELECT	Output	This land is tied high on the processor package and is used by the VR to choose the proper VID table. Refer to the Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket for more information.



Table 25. Signal Description (Sheet 9 of 9)

Name	Туре	Description
VRDSEL	Input	This input should be left as a no connect in order for the processor to boot. The processor will not boot on legacy platforms where this land is connected to V _{SS} .
VSS	Input	VSS are the ground pins for the processor and should be connected to the system ground plane.
VSSA	Input	VSSA is the isolated ground for internal PLLs.
VSS_SENSE	Output	VSS_SENSE is an isolated low impedance connection to processor core V _{SS} . It can be used to sense or measure ground near the silicon with little noise.
VSS_MB_ REGULATION	Output	This land is provided as a voltage regulator feedback sense point for V _{SS} . It is connected internally in the processor package to the sense point land V27 as described in the <i>Voltage Regulator-Down (VRD)</i> 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket.
VTT	Input	Miscellaneous voltage supply.
VTT_OUT_LEFT VTT_OUT_RIGHT	Output	The VTT_OUT_LEFT and VTT_OUT_RIGHT signals are included to provide a voltage supply for some signals that require termination to V_{TT} on the motherboard.
VTT_SEL	Output	The VTT_SEL signal is used to select the correct V_{TT} voltage level for the processor. This land is connected internally in the package to V_{TT} .

§ §



5 Thermal Specifications and Design Considerations

5.1 Processor Thermal Specifications

The processor requires a thermal solution to maintain temperatures within the operating limits as described in Section 5.1.1. Any attempt to operate the processor outside these operating limits may result in permanent damage to the processor and potentially other components within the system. As processor technology changes, thermal management becomes increasingly crucial when building computer systems. Maintaining the proper thermal environment is key to reliable, long-term system operation.

A complete thermal solution includes both component and system level thermal management features. Component level thermal solutions can include active or passive heatsinks attached to the processor Integrated Heat Spreader (IHS). Typical system level thermal solutions may consist of system fans combined with ducting and venting.

For more information on designing a component level thermal solution, refer to the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2).

Note:

The boxed processor will ship with a component thermal solution. Refer to Chapter 7 for details on the boxed processor.

5.1.1 Thermal Specifications

To allow for the optimal operation and long-term reliability of Intel processor-based systems, the system/processor thermal solution should be designed such that the processor remains within the minimum and maximum case temperature (T_C) specifications when operating at or below the Thermal Design Power (TDP) value listed per frequency in Table 26. Thermal solutions not designed to provide this level of thermal capability may affect the long-term reliability of the processor and system. For more details on thermal solution design, refer to the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2).

The processor uses a methodology for managing processor temperatures which is intended to support acoustic noise reduction through fan speed control. Selection of the appropriate fan speed is based on the relative temperature data reported by the processor's Platform Environment Control Interface (PECI) bus as described in Section 5.4.1.1. The temperature reported over PECI is always a negative value and represents a delta below the onset of thermal control circuit (TCC) activation, as indicated by PROCHOT# (see Section 5.2). Systems that implement fan speed control must be designed to take these conditions in to account. Systems that do not alter the fan speed only need to ensure the case temperature meets the thermal profile specifications.

To determine a processor's case temperature specification based on the thermal profile, it is necessary to accurately measure processor power dissipation. Intel has developed a methodology for accurate power measurement that correlates to Intel test temperature and voltage conditions. Refer to the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2) and the *Processor Power Characterization Methodology* for the details of this methodology.



The case temperature is defined at the geometric top center of the processor. Analysis indicates that real applications are unlikely to cause the processor to consume maximum power dissipation for sustained time periods. Intel recommends that complete thermal solution designs target the Thermal Design Power (TDP) indicated in Table 26 instead of the maximum processor power consumption. The Thermal Monitor feature is designed to protect the processor in the unlikely event that an application exceeds the TDP recommendation for a sustained periods of time. For more details on the usage of this feature, refer to Section 5.2. To ensure maximum flexibility for future requirements, systems should be designed to the 775_VR_CONFIG_06 guidelines, even if a processor with a lower thermal dissipation is currently planned. In all cases the Thermal Monitor and Thermal Monitor 2 feature must be enabled for the processor to remain within specification.

Table 26. **Processor Thermal Specifications**

Processor Number	Core Frequency (GHz)	Thermal Design Power (W) ^{1,2}	Extended HALT Power (w) ³	775_VR_ CONFIG_06 Guidance ⁴	Minimum T _C (°C)	Maximum T _C (°C)	Notes
E2220	2.4	65.0	8		5		5
E2200	2.2	65.0	8	775_VR_	5		5
E2180	2.0	65.0	8	CONFIG_06	5	Table 28, Figure 16	5
E2160	1.8	65.0	8	Guidance	5		5
E2140	1.6	65.0	8		5		5
E2160	1.8	65.0	8	775_VR_	5	Table 27,	6
E2140	1.6	65.0	8	CONFIG_06 Guidance	5	Figure 15	6

NOTES:

- Thermal Design Power (TDP) should be used for processor thermal solution design targets. The TDP is not the maximum power that the processor can dissipate.
- 2. This table shows the maximum TDP for a given frequency range. Individual processors may have a lower TDP. Therefore, the maximum T_C will vary depending on the TDP of the individual processor. Refer to thermal profile figure and associated table for the allowed combinations of power and T_C.

 3. Specification is at 35 °C T_C and typical voltage loadline. Specification is ensured by design characterization and not 100% tested.
- 775_VR_CONFIG_06 guidelines provide a design target for meeting future thermal requirements.
- 5. These processors have CPUID = 06FDh.
- 6. These processors have CPUID = 06F2h.



Table 27. Thermal Profile (Intel® Pentium® Dual-Core Processors with CPUID = 06F2h)

Power (W)	Maximum Tc (°C)
0	43.2
2	43.8
4	44.3
6	44.9
8	45.4
10	46.0
12	46.6
14	47.1
16	47.7
18	48.2
20	48.8
22	49.4

Power (W)	Maximum Tc (°C)
24	49.9
26	50.5
28	51.0
30	51.6
32	52.2
34	52.7
36	53.3
38	53.8
40	54.4
42	55.0
44	55.5
46	56.1

Maximum Tc (°C)
56.6
57.2
57.8
58.3
58.9
59.4
60.0
60.6
61.1
61.4

Figure 15. Thermal Profile (Intel® Pentium® Dual-Core Processors with CPUID = 06F2h)

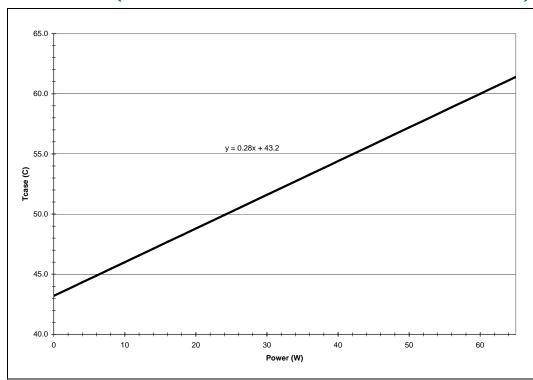




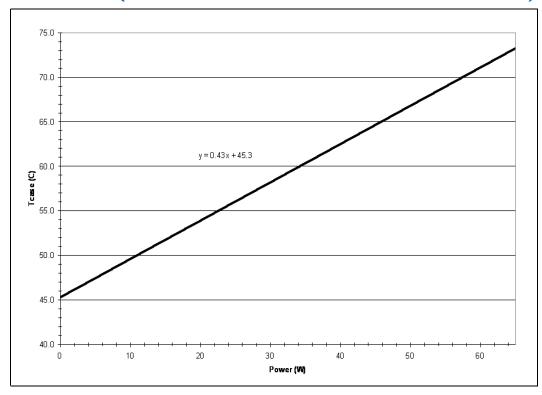
Table 28. Thermal Profile (Intel® Pentium® Dual-Core Processors with CPUID = 06FDh)

Power (W)	Maximum Tc (°C)
0	45.3
2	46.2
4	47.0
6	47.9
8	48.7
10	49.6
12	50.5
14	51.3
16	52.2
18	53.0
20	53.9
22	54.8

Maximum Tc (°C)
55.6
56.5
57.3
58.2
59.1
59.9
60.8
61.6
62.5
63.4
64.2
65.1

Power (W)	Maximum Tc (°C)
48	65.9
50	66.8
52	67.7
54	68.5
56	69.4
58	70.2
60	71.1
62	72.0
64	72.8
65	73.3

Figure 16. Thermal Profile (Intel® Pentium® Dual-Core Processors with CPUID = 06FDh)

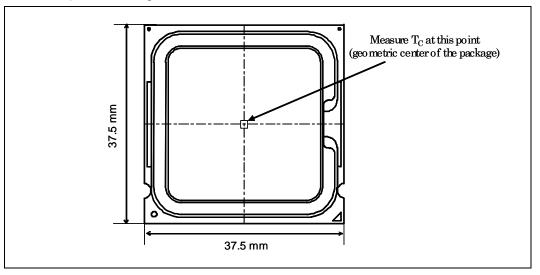




5.1.2 Thermal Metrology

The maximum and minimum case temperatures (T_C) for the processor is specified in Table 26. This temperature specification is meant to help ensure proper operation of the processor. Figure 17 illustrates where Intel recommends T_C thermal measurements should be made. For detailed guidelines on temperature measurement methodology, refer to the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2).

Figure 17. Case Temperature (T_C) Measurement Location



5.2 Processor Thermal Features

5.2.1 Thermal Monitor

The Thermal Monitor feature helps control the processor temperature by activating the thermal control circuit (TCC) when the processor silicon reaches its maximum operating temperature. The TCC reduces processor power consumption by modulating (starting and stopping) the internal processor core clocks. **The Thermal Monitor feature must be enabled for the processor to be operating within specifications.** The temperature at which Thermal Monitor activates the thermal control circuit is not user configurable and is not software visible. Bus traffic is snooped in the normal manner, and interrupt requests are latched (and serviced during the time that the clocks are on) while the TCC is active.

When the Thermal Monitor feature is enabled, and a high temperature situation exists (i.e., TCC is active), the clocks will be modulated by alternately turning the clocks off and on at a duty cycle specific to the processor (typically 30–50%). Clocks often will not be off for more than 3.0 microseconds when the TCC is active. Cycle times are processor speed dependent and will decrease as processor core frequencies increase. A small amount of hysteresis has been included to prevent rapid active/inactive transitions of the TCC when the processor temperature is near its maximum operating temperature. Once the temperature has dropped below the maximum operating temperature, and the hysteresis timer has expired, the TCC goes inactive and clock modulation ceases.

With a properly designed and characterized thermal solution, it is anticipated that the TCC would only be activated for very short periods of time when running the most power intensive applications. The processor performance impact due to these brief periods of TCC activation is expected to be so minor that it would be immeasurable. An



under-designed thermal solution that is not able to prevent excessive activation of the TCC in the anticipated ambient environment may cause a noticeable performance loss, and in some cases may result in a $T_{\rm C}$ that exceeds the specified maximum temperature and may affect the long-term reliability of the processor. In addition, a thermal solution that is significantly under-designed may not be capable of cooling the processor even when the TCC is active continuously. Refer to the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2) for information on designing a thermal solution.

The duty cycle for the TCC, when activated by the Thermal Monitor, is factory configured and cannot be modified. The Thermal Monitor does not require any additional hardware, software drivers, or interrupt handling routines.

5.2.2 Thermal Monitor 2

The processor also supports an additional power reduction capability known as Thermal Monitor 2. This mechanism provides an efficient means for limiting the processor temperature by reducing the power consumption within the processor.

When Thermal Monitor 2 is enabled, and a high temperature situation is detected, the Thermal Control Circuit (TCC) will be activated. The TCC causes the processor to adjust its operating frequency (via the bus multiplier) and input voltage (via the VID signals). This combination of reduced frequency and VID results in a reduction to the processor power consumption.

A processor enabled for Thermal Monitor 2 includes two operating points, each consisting of a specific operating frequency and voltage. The first operating point represents the normal operating condition for the processor. Under this condition, the core-frequency-to-FSB multiple used by the processor is that contained in the CLOCK_FLEX_MAX MSR and the VID is that specified in Table 5. These parameters represent normal system operation.

The second operating point consists of both a lower operating frequency and voltage. When the TCC is activated, the processor automatically transitions to the new frequency. This transition occurs very rapidly (on the order of 5 μ s). During the frequency transition, the processor is unable to service any bus requests, and consequently, all bus traffic is blocked. Edge-triggered interrupts will be latched and kept pending until the processor resumes operation at the new frequency.

Once the new operating frequency is engaged, the processor will transition to the new core operating voltage by issuing a new VID code to the voltage regulator. The voltage regulator must support dynamic VID steps to support Thermal Monitor 2. During the voltage change, it will be necessary to transition through multiple VID codes to reach the target operating voltage. Each step will likely be one VID table entry (see Table 5). The processor continues to execute instructions during the voltage transition. Operation at the lower voltage reduces the power consumption of the processor.

A small amount of hysteresis has been included to prevent rapid active/inactive transitions of the TCC when the processor temperature is near its maximum operating temperature. Once the temperature has dropped below the maximum operating temperature, and the hysteresis timer has expired, the operating frequency and voltage transition back to the normal system operating point. Transition of the VID code will occur first, to ensure proper operation once the processor reaches its normal operating frequency. Refer to Figure 18 for an illustration of this ordering.



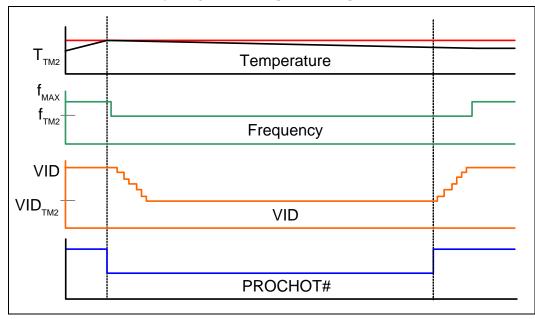


Figure 18. Thermal Monitor 2 Frequency and Voltage Ordering

The PROCHOT# signal is asserted when a high temperature situation is detected, regardless of whether Thermal Monitor or Thermal Monitor 2 is enabled.

It should be noted that the Thermal Monitor 2 TCC cannot be activated via the on demand mode. The Thermal Monitor TCC, however, can be activated through the use of the on demand mode.

5.2.3 On-Demand Mode

The processor provides an auxiliary mechanism that allows system software to force the processor to reduce its power consumption. This mechanism is referred to as "On-Demand" mode and is distinct from the Thermal Monitor feature. On-Demand mode is intended as a means to reduce system level power consumption. Systems using the processor must not rely on software usage of this mechanism to limit the processor temperature.

The processor provides an auxiliary mechanism that allows system software to force the processor to reduce its power consumption. This mechanism is referred to as "On-Demand" mode and is distinct from the Thermal Monitor and Thermal Monitor 2 features. On-Demand mode is intended as a means to reduce system level power consumption. Systems must not rely on software usage of this mechanism to limit the processor temperature. If bit 4 of the IA32_CLOCK_MODULATION MSR is set to a '1', the processor will immediately reduce its power consumption via modulation (starting and stopping) of the internal core clock, independent of the processor temperature. When using On-Demand mode, the duty cycle of the clock modulation is programmable via bits 3:1 of the same IA32_CLOCK_MODULATION MSR. In On-Demand mode, the duty cycle can be programmed from 12.5% on/ 87.5% off to 87.5% on/ 12.5% off in 12.5% increments. On-Demand mode may be used in conjunction with the Thermal Monitor; however, if the system tries to enable On-Demand mode at the same time the TCC is engaged, the factory configured duty cycle of the TCC will override the duty cycle selected by the On-Demand mode.



5.2.4 PROCHOT# Signal

An external signal, PROCHOT# (processor hot), is asserted when the processor core temperature has reached its maximum operating temperature. If the Thermal Monitor is enabled (note that the Thermal Monitor must be enabled for the processor to be operating within specification), the TCC will be active when PROCHOT# is asserted. The processor can be configured to generate an interrupt upon the assertion or deassertion of PROCHOT#.

As an output, PROCHOT# (Processor Hot) will go active when the processor temperature monitoring sensor detects that one or both cores has reached its maximum safe operating temperature. This indicates that the processor Thermal Control Circuit (TCC) has been activated, if enabled. As an input, assertion of PROCHOT# by the system will activate the TCC, if enabled, for both cores. The TCC will remain active until the system de-asserts PROCHOT#.

PROCHOT# allows for some protection of various components from over-temperature situations. The PROCHOT# signal is bi-directional in that it can either signal when the processor (either core) has reached its maximum operating temperature or be driven from an external source to activate the TCC. The ability to activate the TCC via PROCHOT# can provide a means for thermal protection of system components.

PROCHOT# can allow VR thermal designs to target maximum sustained current instead of maximum current. Systems should still provide proper cooling for the VR, and rely on PROCHOT# only as a backup in case of system cooling failure. The system thermal design should allow the power delivery circuitry to operate within its temperature specification even while the processor is operating at its Thermal Design Power. With a properly designed and characterized thermal solution, it is anticipated that PROCHOT# would only be asserted for very short periods of time when running the most power intensive applications. An under-designed thermal solution that is not able to prevent excessive assertion of PROCHOT# in the anticipated ambient environment may cause a noticeable performance loss. Refer to the *Voltage Regulator-Down (VRD) 11.0 Processor Power Delivery Design Guidelines For Desktop LGA775 Socket* for details on implementing the bi-directional PROCHOT# feature.

5.2.5 THERMTRIP# Signal

Regardless of whether or not Thermal Monitor or Thermal Monitor 2 is enabled, in the event of a catastrophic cooling failure, the processor will automatically shut down when the silicon has reached an elevated temperature (refer to the THERMTRIP# definition in Table 25). At this point, the FSB signal THERMTRIP# will go active and stay active as described in Table 25. THERMTRIP# activation is independent of processor activity and does not generate any bus cycles. If THERMTRIP# is asserted, processor core voltage (V_{CC}) must be removed within the timeframe defined in Table 11.



5.3 Thermal Diode

The processor incorporates an on-die PNP transistor where the base emitter junction is used as a thermal "diode", with its collector shorted to ground. A thermal sensor located on the system board may monitor the die temperature of the processor for thermal management and fan speed control. Table 29, Table 30, and Table 31 provide the "diode" parameter and interface specifications. Two different sets of "diode" parameters are listed in Table 29 and Table 30. The Diode Model parameters (Table 29) apply to traditional thermal sensors that use the Diode Equation to determine the processor temperature. Transistor Model parameters (Table 30) have been added to support thermal sensors that use the transistor equation method. The Transistor Model may provide more accurate temperature measurements when the diode ideality factor is closer to the maximum or minimum limits. This thermal "diode" is separate from the Thermal Monitor's thermal sensor and cannot be used to predict the behavior of the Thermal Monitor.

 $T_{CONTROL}$ is a temperature specification based on a temperature reading from the thermal diode. The value for $T_{CONTROL}$ will be calibrated in manufacturing and configured for each processor. The $T_{CONTROL}$ temperature for a given processor can be obtained by reading a MSR in the processor. The $T_{CONTROL}$ value that is read from the MSR needs to be converted from Hexadecimal to Decimal and added to a base value of 50 $^{\circ}\mathrm{C}$.

The value of T_{CONTROL} may vary from 00 h to 1E h (0 to 30 °C).

When T_{DIODE} is above $T_{CONTROL}$, then T_{C} must be at or below T_{C_MAX} as defined by the thermal profile in Table 27; otherwise, the processor temperature can be maintained at $T_{CONTROL}$ (or lower) as measured by the thermal diode.

Table 29. Thermal "Diode" Parameters using Diode Model

Symbol	Parameter	Min	Тур	Max	Unit	Notes
I _{FW}	Forward Bias Current	5	_	200	μΑ	1
n	Diode Ideality Factor	1.000	1.009	1.050	-	2, 3, 4
R _T	Series Resistance	2.79	4.52	6.24	Ω	2, 3, 5

NOTES:

- Intel does not support or recommend operation of the thermal diode under reverse bias.
- 2. Preliminary data. Will be characterized across a temperature range of 50 80 °C.
- 3. Not 100% tested. Specified by design characterization.
- 4. The ideality factor, n, represents the deviation from ideal diode behavior as exemplified by the diode equation:

$$I_{FW} = I_S * (e^{qV_D/nkT} - 1)$$

where I_S = saturation current, q = electronic charge, V_D = voltage across the diode, k = Boltzmann Constant, and T = absolute temperature (Kelvin).

5. The series resistance, R_T, is provided to allow for a more accurate measurement of the junction temperature. R_T, as defined, includes the lands of the processor but does not include any socket resistance or board trace resistance between the socket and the external remote diode thermal sensor. R_T can be used by remote diode thermal sensors with automatic series resistance cancellation to calibrate out this error term. Another application is that a temperature offset can be manually calculated and programmed into an offset register in the remote diode thermal sensors as exemplified by the equation:

$$T_{error} = [R_T * (N-1) * I_{FWmin}] / [nk/q * In N]$$

where $T_{error}=$ sensor temperature error, N= sensor current ratio, k= Boltzmann Constant, q= electronic charge.



Table 30. Thermal "Diode" Parameters using Transistor Model

Symbol	Parameter	Min	Тур	Max	Unit	Notes
I _{FW}	Forward Bias Current	5	_	200	μΑ	1, 2
I _E	Emitter Current	5	_	200		
n _Q	Transistor Ideality	0.997	1.001	1.005	-	3, 4, 5
Beta		0.391	_	0.760		3, 4
R _T	Series Resistance	2.79	4.52	6.24	Ω	3, 6

NOTES:

- 1. Intel does not support or recommend operation of the thermal diode under reverse bias.
- 2. Same as I_{FW} in Table 29.
- 3. Preliminary data. Will be characterized across a temperature range of 50–80 °C.
- 4. Not 100% tested. Specified by design characterization.
- 5. The ideality factor, nQ, represents the deviation from ideal transistor model behavior as exemplified by the equation for the collector current:

$$I_C = I_S * (e^{qV_{BE}/n_QkT} -1)$$

Where I_S = saturation current, q = electronic charge, V_{BE} = voltage across the transistor base emitter junction (same nodes as VD), k = Boltzmann Constant, and T = absolute temperature (Kelvin).

 The series resistance, R_T, provided in the Diode Model Table (Table 29) can be used for more accurate readings as needed.

The Intel $^{\circledR}$ Pentium $^{\circledR}$ Dual-Core Desktop processor E2000 series does not support the diode correction offset that exists on other Intel processors.

Table 31. Thermal Diode Interface

Signal Name	Land Number	Signal Description	
THERMDA	AL1	diode anode	
THERMDC	AK1	diode cathode	

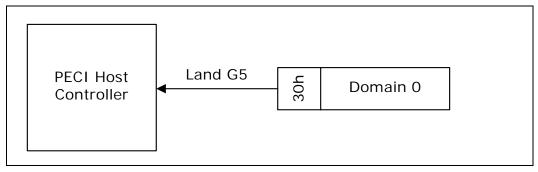


5.4 Platform Environment Control Interface (PECI)

5.4.1 Introduction

PECI offers an interface for thermal monitoring of Intel processor and chipset components. It uses a single wire, thus alleviating routing congestion issues. Figure 19 shows an example of the PECI topology in a system. PECI uses CRC checking on the host side to ensure reliable transfers between the host and client devices. Also, data transfer speeds across the PECI interface are negotiable within a wide range (2 Kbps to 2 Mbps). The PECI interface on the processor is disabled by default and must be enabled through BIOS.

Figure 19. Processor PECI Topology



5.4.1.1 Key Difference with Legacy Diode-Based Thermal Management

Fan speed control solutions based on PECI uses a $T_{CONTROL}$ value stored in the processor IA32_TEMPERATURE_TARGET MSR. The $T_{CONTROL}$ MSR uses the same offset temperature format as PECI though it contains no sign bit. Thermal management devices should infer the $T_{CONTROL}$ value as negative. Thermal management algorithms should use the relative temperature value delivered over PECI in conjunction with the $T_{CONTROL}$ MSR value to control or optimize fan speeds. Figure 20 shows a conceptual fan control diagram using PECI temperatures.

The relative temperature value reported over PECI represents the delta below the onset of thermal control circuit (TCC) activation as indicated by PROCHOT# assertions. As the temperature approaches TCC activation, the PECI value approaches zero. TCC activates at a PECI count of zero.



Figure 20. Conceptual Fan Control on PECI-Based Platforms

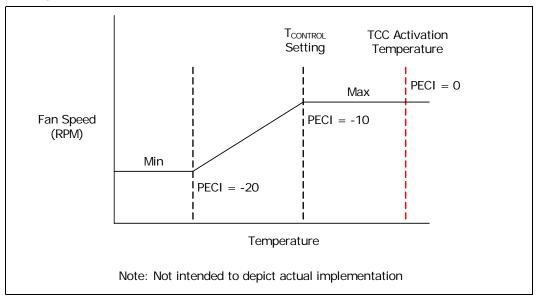
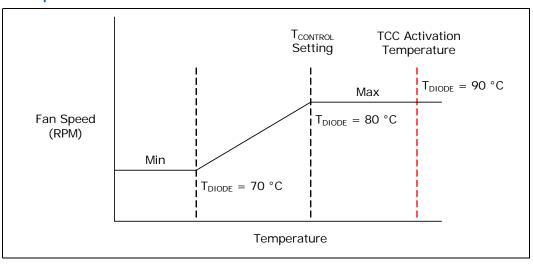


Figure 21. Conceptual Fan Control on Thermal Diode-Based Platforms





5.4.2 PECI Specifications

5.4.2.1 PECI Device Address

The PECI device address for the socket is 30h. For more information on PECI domains, refer to the *Platform Environment Control Interface Specification*.

5.4.2.2 PECI Command Support

PECI command support is covered in detail in the *Platform Environment Control Interface Specification*. Refer to this document for details on supported PECI command function and codes.

5.4.2.3 PECI Fault Handling Requirements

PECI is largely a fault tolerant interface, including noise immunity and error checking improvements over other comparable industry standard interfaces. The PECI client is as reliable as the device that it is embedded in, and thus given operating conditions that fall under the specification, the PECI will always respond to requests and the protocol itself can be relied upon to detect any transmission failures. There are, however, certain scenarios where the PECI is know to be unresponsive.

Prior to a power on RESET# and during RESET# assertion, PECI is not ensured to provide reliable thermal data. System designs should implement a default power-on condition that ensures proper processor operation during the time frame when reliable data is not available via PECI.

To protect platforms from potential operational or safety issues due to an abnormal condition on PECI, the Host controller should take action to protect the system from possible damaging states. It is recommended that the PECI host controller take appropriate action to protect the client processor device if valid temperature readings have not been obtained in response to three consecutive gettemp()s or for a one second time interval. The host controller may also implement an alert to software in the event of a critical or continuous fault condition.

5.4.2.4 PECI GetTemp0() Error Code Support

The error codes supported for the processor GetTemp() command are listed in Table 32.

Table 32. GetTemp0() Error Codes

Error Code	Description
8000h	General sensor error
8002h	Sensor is operational, but has detected a temperature below its operational range (underflow).

§ §





6 **Features**

Power-On Configuration Options 6.1

Several configuration options can be configured by hardware. The processor samples the hardware configuration at reset, on the active-to-inactive transition of RESET#. For specifications on these options, refer to Table 33.

The sampled information configures the processor for subsequent operation. These configuration options cannot be changed except by another reset. All resets reconfigure the processor; for reset purposes, the processor does not distinguish between a "warm" reset and a "power-on" reset.

Table 33. **Power-On Configuration Option Signals**

Configuration Option	Signal ^{1,2,3}		
Output tristate	SMI#		
Execute BIST	A3#		
Disable dynamic bus parking	A25#		
Symmetric agent arbitration ID	BR0#		
RESERVED	A[8:5]#, A[24:11]#, A[35:26]#		

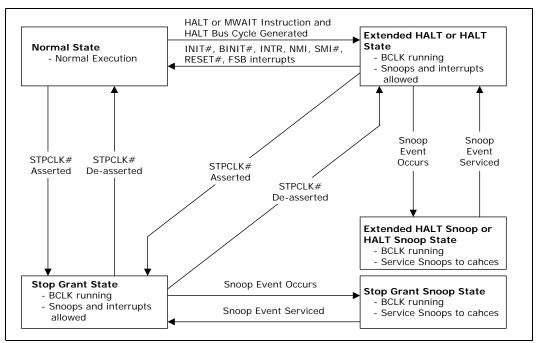
- Asserting this signal during RESET# will select the corresponding option.
 Address signals not identified in this table as configuration options should not be asserted during RESET#.
- 3. Disabling of any of the cores within the processor must be handled by configuring the EXT_CONFIG Model Specific Register (MSR). This MSR will allow for the disabling of a single core.



6.2 Clock Control and Low Power States

The processor allows the use of AutoHALT and Stop-Grant states to reduce power consumption by stopping the clock to internal sections of the processor, depending on each particular state. See Figure 22 for a visual representation of the processor low power states.

Figure 22. Processor Low Power State Machine



6.2.1 Normal State

This is the normal operating state for the processor.

6.2.2 HALT and Extended HALT Powerdown States

The processor supports the HALT or Extended HALT powerdown state. The Extended HALT powerdown must be enabled via the BIOS for the processor to remain within its specification.

The Extended HALT state is a lower power state as compared to the Stop Grant State.

If Extended HALT is not enabled, the default powerdown state entered will be HALT. Refer to the sections below for details about the HALT and Extended HALT states.



6.2.2.1 HALT Powerdown State

HALT is a low power state entered when all the processor cores have executed the HALT or MWAIT instructions. When one of the processor cores executes the HALT instruction, that processor core is halted, however, the other processor continues normal operation. The processor will transition to the Normal state upon the occurrence of SMI#, INIT#, or LINT[1:0] (NMI, INTR). RESET# will cause the processor to immediately initialize itself.

The return from a System Management Interrupt (SMI) handler can be to either Normal Mode or the HALT Power Down state. See the *Intel Architecture Software Developer's Manual, Volume III: System Programmer's Guide* for more information.

The system can generate a STPCLK# while the processor is in the HALT powerdown state. When the system de-asserts the STPCLK# interrupt, the processor will return execution to the HALT state.

While in HALT powerdown state, the processor will process bus snoops.

6.2.2.2 Extended HALT Powerdown State

Extended HALT is a low power state entered when all processor cores have executed the HALT or MWAIT instructions and Extended HALT has been enabled via the BIOS. When one of the processor cores executes the HALT instruction, that logical processor is halted; however, the other processor continues normal operation. The Extended HALT powerdown state must be enabled via the BIOS for the processor to remain within its specification.

The processor will automatically transition to a lower frequency and voltage operating point before entering the Extended HALT state. Note that the processor FSB frequency is not altered; only the internal core frequency is changed. When entering the low power state, the processor will first switch to the lower bus ratio and then transition to the lower VID.

While in Extended HALT state, the processor will process bus snoops.

The processor exits the Extended HALT state when a break event occurs. When the processor exits the Extended HALT state, it will resume operation at the lower frequency, transition the VID to the original value, and then change the bus ratio back to the original value.

6.2.3 Stop Grant and Extended Stop Grant States

The processor supports the Stop Grant and Extended Stop Grant states. The Extended Stop Grant state is a feature that must be configured and enabled via the BIOS. Refer to the following sections for details about the Stop Grant and Extended Stop Grant states.



6.2.3.1 Stop-Grant State

When the STPCLK# signal is asserted, the Stop Grant state of the processor is entered 20 bus clocks after the response phase of the processor-issued Stop Grant Acknowledge special bus cycle.

Since the GTL+ signals receive power from the FSB, these signals should not be driven (allowing the level to return to $V_{\rm TT}$) for minimum power drawn by the termination resistors in this state. In addition, all other input signals on the FSB should be driven to the inactive state.

RESET# will cause the processor to immediately initialize itself, but the processor will stay in Stop-Grant state. A transition back to the Normal state will occur with the deassertion of the STPCLK# signal.

A transition to the Grant Snoop state will occur when the processor detects a snoop on the FSB (see Section 6.2.4).

While in the Stop-Grant State, SMI#, INIT#, and LINT[1:0] will be latched by the processor, and only serviced when the processor returns to the Normal State. Only one occurrence of each event will be recognized upon return to the Normal state.

While in Stop-Grant state, the processor will process a FSB snoop.

6.2.3.2 Extended Stop Grant State

Extended Stop Grant is a low power state entered when the STPCLK# signal is asserted and Extended Stop Grant has been enabled via the BIOS.

The processor will automatically transition to a lower frequency and voltage operating point before entering the Extended Stop Grant state. When entering the low power state, the processor will first switch to the lower bus ratio and then transition to the lower VID.

The processor exits the Extended Stop Grant state when a break event occurs. When the processor exits the Extended Stop Grant state, it will resume operation at the lower frequency, transition the VID to the original value, and then change the bus ratio back to the original value.

6.2.4 Extended HALT Snoop State, HALT Snoop State, Extended Stop Grant Snoop State, and Stop Grant Snoop State

The Extended HALT Snoop State is used in conjunction with the new Extended HALT state. If Extended HALT state is not enabled in the BIOS, the default Snoop State entered will be the HALT Snoop State. Refer to the following sections for details on HALT Snoop State, Stop Grant Snoop State, Extended HALT Snoop State, and Extended Stop Grant Snoop State.

6.2.4.1 HALT Snoop State, Stop Grant Snoop State

The processor will respond to snoop transactions on the FSB while in Stop-Grant state or in HALT powerdown state. During a snoop transaction, the processor enters the HALT Snoop State: Stop Grant Snoop state. The processor will stay in this state until the snoop on the FSB has been serviced (whether by the processor or another agent on the FSB). After the snoop is serviced, the processor will return to the Stop Grant state or HALT powerdown state, as appropriate.



6.2.4.2 Extended HALT Snoop State, Extended Stop Grant Snoop State

The processor will remain in the lower bus ratio and VID operating point of the Extended HALT state or Extended Stop Grant state. While in the Extended HALT Snoop State or Extended Stop Grant Snoop State, snoops are handled the same way as in the HALT Snoop State or Stop Grant Snoop State. After the snoop is serviced, the processor will return to the Extended HALT state or Extended Stop Grant state.

6.3 Enhanced Intel SpeedStep® Technology

The processor supports Enhanced Intel SpeedStep technology. This technology enables the processor to switch between multiple frequency and voltage points, which results in platform power savings. Enhanced Intel SpeedStep Technology requires support for dynamic VID transitions in the platform. Switching between voltage/frequency states is software controlled.

Note:

Not all processors are capable of supporting Enhanced Intel SpeedStep Technology. More details on which processor frequencies will support this feature will be provided in future releases of the Intel® Pentium® Dual-Core Desktop Processor E2000 Series Specification Update when available.

Enhanced Intel SpeedStep Technology creates processor performance states (P-states) or voltage/frequency operating points. P-states are lower power capability states within the Normal state as shown in Figure 22. Enhanced Intel SpeedStep Technology enables real-time dynamic switching between frequency and voltage points. It alters the performance of the processor by changing the bus to core frequency ratio and voltage. This allows the processor to run at different core frequencies and voltages to best serve the performance and power requirements of the processor and system. The processor has hardware logic that coordinates the requested voltage (VID) between the processor cores. The highest voltage that is requested for either of the processor cores is selected for that processor package. Note that the front side bus is not altered; only the internal core frequency is changed. To run at reduced power consumption, the voltage is altered in step with the bus ratio.

The following are key features of Enhanced Intel SpeedStep Technology:

- Multiple voltage/frequency operating points provide optimal performance at reduced power consumption.
- Voltage/frequency selection is software controlled by writing to processor MSR's (Model Specific Registers), thus eliminating chipset dependency.
 - If the target frequency is higher than the current frequency, V_{CC} is incriminated in steps (+12.5 mV) by placing a new value on the VID signals and the processor shifts to the new frequency. Note that the top frequency for the processor can not be exceeded.
 - If the target frequency is lower than the current frequency, the processor shifts to the new frequency and V_{CC} is then decremented in steps (-12.5 mV) by changing the target VID through the VID signals.





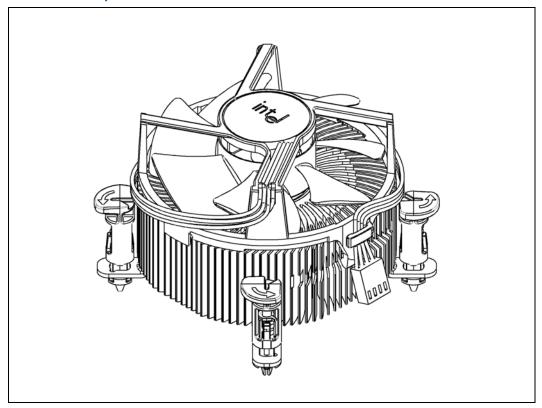
7 Boxed Processor Specifications

The processor will also be offered as an Intel boxed processor. Intel boxed processors are intended for system integrators who build systems from baseboards and standard components. The boxed processor will be supplied with a cooling solution. This chapter documents baseboard and system requirements for the cooling solution that will be supplied with the boxed processor. This chapter is particularly important for OEMs that manufacture baseboards for system integrators. Unless otherwise noted, all figures in this chapter are dimensioned in millimeters and inches [in brackets]. Figure 23 shows a mechanical representation of a boxed processor.

Note:

Drawings in this section reflect only the specifications on the Intel boxed processor product. These dimensions should not be used as a generic keep-out zone for all cooling solutions. It is the system designers' responsibility to consider their proprietary cooling solution when designing to the required keep-out zone on their system platforms and chassis. Refer to the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2) for further guidance. Contact your local Intel Sales Representative for this document.

Figure 23. Mechanical Representation of the Boxed Processor



NOTE: The airflow of the fan heatsink is into the center and out of the sides of the fan heatsink.



7.1 Mechanical Specifications

7.1.1 Boxed Processor Cooling Solution Dimensions

This section documents the mechanical specifications of the boxed processor. The boxed processor will be shipped with an unattached fan heatsink. Figure 23 shows a mechanical representation of the boxed processor.

Clearance is required around the fan heatsink to ensure unimpeded airflow for proper cooling. The physical space requirements and dimensions for the boxed processor with assembled fan heatsink are shown in Figure 24 (Side View), and Figure 25 (Top View). The airspace requirements for the boxed processor fan heatsink must also be incorporated into new baseboard and system designs. Airspace requirements are shown in Figure 29 and Figure 30. Note that some figures have centerlines shown (marked with alphabetic designations) to clarify relative dimensioning.

Figure 24. Space Requirements for the Boxed Processor (Side View)

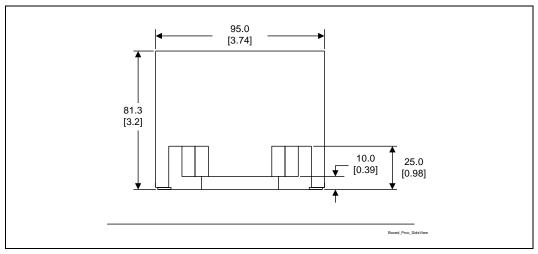
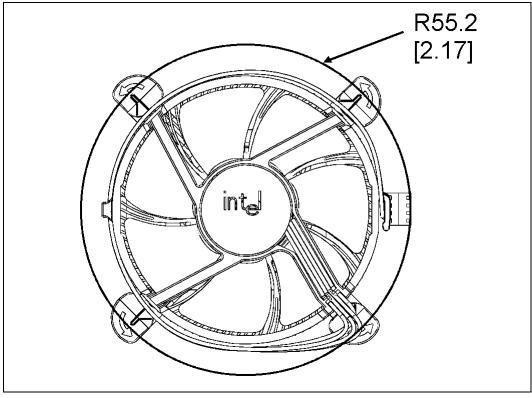




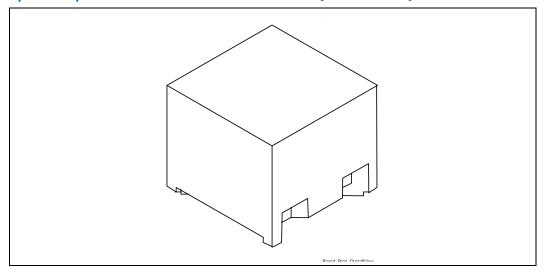
Figure 25. Space Requirements for the Boxed Processor (Top View)



NOTES:

 Diagram does not show the attached hardware for the clip design and is provided only as a mechanical representation.

Figure 26. Space Requirements for the Boxed Processor (Overall View)





7.1.2 Boxed Processor Fan Heatsink Weight

The boxed processor fan heatsink will not weigh more than 550 grams. See Chapter 5 and the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2) for details on the processor weight and heatsink requirements.

7.1.3 Boxed Processor Retention Mechanism and Heatsink Attach Clip Assembly

The boxed processor thermal solution requires a heatsink attach clip assembly, to secure the processor and fan heatsink in the baseboard socket. The boxed processor will ship with the heatsink attach clip assembly.

7.2 Electrical Requirements

7.2.1 Fan Heatsink Power Supply

The processor's fan heatsink requires a +12 V power supply. A fan power cable will be shipped with the boxed processor to draw power from a power header on the baseboard. The power cable connector and pinout are shown in Figure 27. Baseboards must provide a matched power header to support the boxed processor. Table 34 contains specifications for the input and output signals at the fan heatsink connector.

The fan heatsink outputs a SENSE signal, which is an open- collector output that pulses at a rate of 2 pulses per fan revolution. A baseboard pull-up resistor provides V_{OH} to match the system board-mounted fan speed monitor requirements, if applicable. Use of the SENSE signal is optional. If the SENSE signal is not used, pin 3 of the connector should be tied to GND.

The fan heatsink receives a PWM signal from the motherboard from the 4th pin of the connector labeled as CONTROL.

The processor's fan heatsink requires a constant +12 V supplied to pin 2 and does not support variable voltage control or 3-pin PWM control.

The power header on the baseboard must be positioned to allow the fan heatsink power cable to reach it. The power header identification and location should be documented in the platform documentation, or on the system board itself. Figure 28 shows the location of the fan power connector relative to the processor socket. The baseboard power header should be positioned within 110 mm [4.33 inches] from the center of the processor socket.



Figure 27. **Boxed Processor Fan Heatsink Power Cable Connector Description**

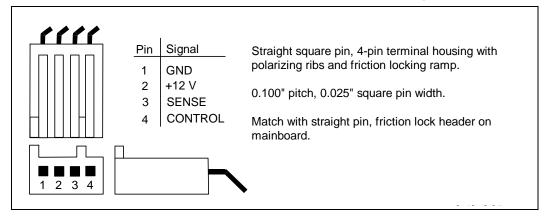


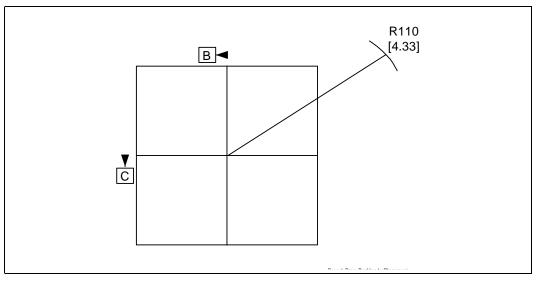
Table 34. **Fan Heatsink Power and Signal Specifications**

Description	Min	Тур	Max	Unit	Notes
+12 V: 12 volt fan power supply	11.4	12	12.6	V	-
IC: - Maximum fan steady-state current draw - Average fan steady-state current draw - Maximum fan start-up current draw - Fan start-up current draw maximum duration	_ _ _ _	1.2 0.5 2.2 1.0	_ _ _ _	A A A Second	-
SENSE: SENSE frequency	_	2	_	pulses per fan revolution	1
CONTROL	21	25	28	kHz	2, 3

- Baseboard should pull this pin up to 5 V with a resistor.
 Open drain type, pulse width modulated.
 Fan will have pull-up resistor for this signal to maximum of 5.25 V.



Figure 28. Baseboard Power Header Placement Relative to Processor Socket



7.3 Thermal Specifications

This section describes the cooling requirements of the fan heatsink solution used by the boxed processor.

7.3.1 Boxed Processor Cooling Requirements

The boxed processor may be directly cooled with a fan heatsink. However, meeting the processor's temperature specification is also a function of the thermal design of the entire system, and ultimately the responsibility of the system integrator. The processor temperature specification is listed in Chapter 5. The boxed processor fan heatsink is able to keep the processor temperature within the specifications (see Table 26) in chassis that provide good thermal management. For the boxed processor fan heatsink to operate properly, it is critical that the airflow provided to the fan heatsink is unimpeded. Airflow of the fan heatsink is into the center and out of the sides of the fan heatsink. Airspace is required around the fan to ensure that the airflow through the fan heatsink is not blocked. Blocking the airflow to the fan heatsink reduces the cooling efficiency and decreases fan life. Figure 29 and Figure 30 illustrate an acceptable airspace clearance for the fan heatsink. The air temperature entering the fan should be kept below 38 °C. Again, meeting the processor's temperature specification is the responsibility of the system integrator.



Figure 29. Boxed Processor Fan Heatsink Airspace Keepout Requirements (side 1 view)

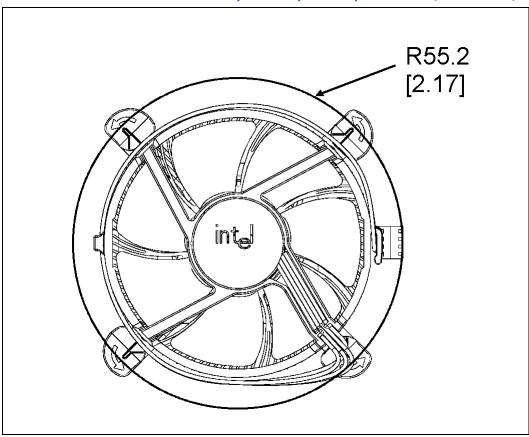
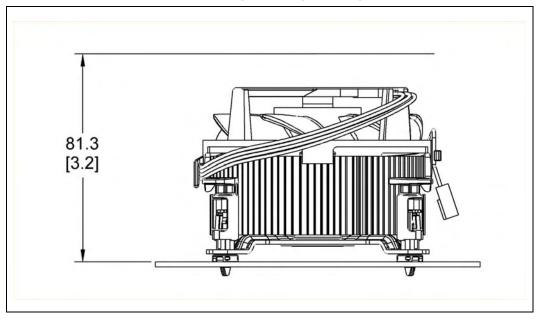


Figure 30. Boxed Processor Fan Heatsink Airspace Keepout Requirements (Side 2 View)





7.3.2 Fan Speed Control Operation (Intel[®] Pentium[®] Dual-Core Desktop Processor E2000 Series)

If the boxed processor fan heatsink 4-pin connector is connected to a 3-pin motherboard header it will operate as follows:

The boxed processor fan will operate at different speeds over a short range of internal chassis temperatures. This allows the processor fan to operate at a lower speed and noise level, while internal chassis temperatures are low. If internal chassis temperature increases beyond a lower set point, the fan speed will rise linearly with the internal temperature until the higher set point is reached. At that point, the fan speed is at its maximum. As fan speed increases, so does fan noise levels. Systems should be designed to provide adequate air around the boxed processor fan heatsink that remains cooler than a lower set point. These set points, represented in Figure 31 and Table 35, can vary by a few degrees from fan heatsink to fan heatsink. The internal chassis temperature should be kept below 38 °C. Meeting the processor's temperature specification (see Chapter 5) is the responsibility of the system integrator.

The motherboard must supply a constant +12 V to the processor's power header to ensure proper operation of the variable speed fan for the boxed processor. Refer to Table 35 for the specific requirements.

Figure 31. Boxed Processor Fan Heatsink Set Points

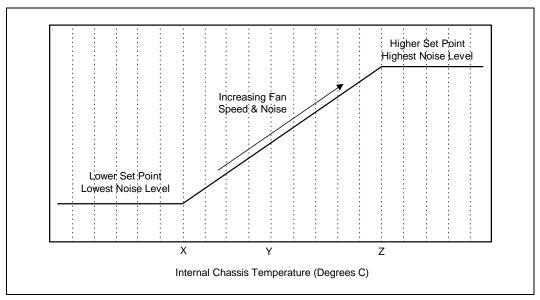




Table 35. Fan Heatsink Power and Signal Specifications

Boxed Processor Fan Heatsink Set Point (°C)	Boxed Processor Fan Speed	Notes
X ≤ 30	When the internal chassis temperature is below or equal to this set point, the fan operates at its lowest speed. Recommended maximum internal chassis temperature for nominal operating environment.	1
Y = 35	When the internal chassis temperature is at this point, the fan operates between its lowest and highest speeds. Recommended maximum internal chassis temperature for worst-case operating environment.	-
Z ≥ 38	When the internal chassis temperature is above or equal to this set point, the fan operates at its highest speed.	-

NOTES:

If the boxed processor fan heatsink 4-pin connector is connected to a 4-pin motherboard header and the motherboard is designed with a fan speed controller with PWM output (CONTROL see Table 34) and remote thermal diode measurement capability the boxed processor will operate as follows:

As processor power has increased the required thermal solutions have generated increasingly more noise. Intel has added an option to the boxed processor that allows system integrators to have a quieter system in the most common usage.

The 4th wire PWM solution provides better control over chassis acoustics. This is achieved by more accurate measurement of processor die temperature through the processor's temperature diode (T-diode). Fan RPM is modulated through the use of an ASIC located on the motherboard that sends out a PWM control signal to the 4th pin of the connector labeled as CONTROL. The fan speed is based on actual processor temperature instead of internal ambient chassis temperatures.

If the new 4-pin active fan heat sink solution is connected to an older 3-pin baseboard CPU fan header it will default back to a thermistor controlled mode, allowing compatibility with existing 3-pin baseboard designs. Under thermistor controlled mode, the fan RPM is automatically varied based on the Tinlet temperature measured by a thermistor located at the fan inlet.

For more details on specific motherboard requirements for 4-wire based fan speed control see the appropriate Thermal and Mechanical Design Guidelines (see Section 1.2).

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^{1.} Set point variance is approximately \pm 1 °C from fan heatsink to fan heatsink.





8 Debug Tools Specifications

8.1 Logic Analyzer Interface (LAI)

Intel is working with two logic analyzer vendors to provide logic analyzer interfaces (LAIs) for use in debugging systems. Tektronix and Agilent should be contacted to get specific information about their logic analyzer interfaces. The following information is general in nature. Specific information must be obtained from the logic analyzer vendor.

Due to the complexity of systems, the LAI is critical in providing the ability to probe and capture FSB signals. There are two sets of considerations to keep in mind when designing a system that can make use of an LAI: mechanical and electrical.

8.1.1 Mechanical Considerations

The LAI is installed between the processor socket and the processor. The LAI lands plug into the processor socket, while the processor lands plug into a socket on the LAI. Cabling that is part of the LAI egresses the system to allow an electrical connection between the processor and a logic analyzer. The maximum volume occupied by the LAI, known as the keepout volume, as well as the cable egress restrictions, should be obtained from the logic analyzer vendor. System designers must make sure that the keepout volume remains unobstructed inside the system. Note that it is possible that the keepout volume reserved for the LAI may differ from the space normally occupied by the processor's heatsink. If this is the case, the logic analyzer vendor will provide a cooling solution as part of the LAI.

8.1.2 Electrical Considerations

The LAI will also affect the electrical performance of the FSB; therefore, it is critical to obtain electrical load models from each of the logic analyzers to be able to run system level simulations to prove that their tool will work in the system. Contact the logic analyzer vendor for electrical specifications and load models for the LAI solution it provides.

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